AN ANALYSIS OF SHEWHART QUALITY CONTROL CHARTS TO MONITOR BOTH THE MEAN AND VARIABILITY

by

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ABSTRACT

When monitoring the mean of a continuous quality measure it is often recommended a separate chart be used to monitor the variability. These charts are traditionally designed separately. This project considers them together as a combined charting procedure and gives recommendations for their design. This is based on an average run length (ARL) analysis. The run length distribution is determined using two methods both based on a Markov chain approach.

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Chapter 1. INTRODUCTION

The distribution of a quality characteristic often has more than one parameter. Each of these parameters may need to be monitored. This often leads to the use of more than one control chart for monitoring the process. In order to improve the sensitivity of a Shewhart chart to small shifts in the parameter of the quality characteristic being monitored, runs rules are added. A runs rule has the general form that if k out of the last m sample statistics fall in the interval (a,b) an out-of-control signal is given, where k < m and a < b. A convenient notation for this runs rule is T (k,m,a,b).

Page (1955), the Western Electric Handbook (1956), Roberts (1957), Bissell (1978), Wheeler (1983), Coleman (1986), Palm (1990), and Champ, Lowry, and Woodall (1992) give discussions of runs rules. A complete description of how a Shewhart chart with runs rules can be expressed as a Markov chain was given by Champ (1986) and Champ and Woodall (1987). Similar, but not as complete, results using a Markov chain approach was obtained by Coleman (1986). Page (1955) and Bissell (1978) used a Markov chain approach for some simple combinations of runs rules. A Markov chain approach was used by Palm (1990) to obtain the percentage points of the run length for the Shewhart \overline{X} -chart. Champ, Lowry, and Woodall (1992) used a Markov chain approach to analyze the Shewhart R- and S-charts. Champ (1986) uses a Markov chain approach to analyze the run length distribution of the combined \overline{X} - and S- control charts used to monitor the mean and standard deviation of a normal distribution. Bragg and St. John (1991) used simulation to analyze the combined \overline{X} - and R- chart supplemented with runs rules. In this research, we will investigate the use of individual Shewhart control charts with supplementary runs rules to monitor both the mean and standard deviation of a quality measure. Although separate charts are used, the charting procedure will be considered as a combined charting procedure. In Chapter 2, the Shewhart \overline{X} , R, and S quality control charts supplemented with runs rules are discussed. The procedures given in the literature for setting up these individual charts are given. Other combined mean and variability charts are discussed. In Chapter 3, the Markov chain approach of Champ and Woodall (1987) is used to develop two methods for analyzing the run length distribution of the combined \overline{X} and R- (or S-) charts supplemented with runs rules. These methods provide simple ways to obtain run length properties of the combined chart when monitoring the mean and standard deviation of a normal distribution. Recommendations for selecting a combined charting procedure are given in Chapter 4.

Chapter 2. COMBINED \overline{X} - AND R- (or S-) CHARTS

2.1 Introduction

The standard practice when monitoring the distribution of a continuous quality measure, X, is to monitor both the distribution mean and standard deviation. These two parameters of the distribution of the quality measure are also referred to as the process mean and standard deviation. The Shewhart \overline{X} - chart is commonly used to monitor the mean. To monitor the standard deviation, either the Shewhart R- or S- chart is used. According to Montgomery (1991), the R-chart is more widely used than the S-chart.

Although the main objective is usually to monitor the mean of a process, Montgomery (1991) among others, recommends using a chart to monitor the variability of the process. The discussion he gives, while being correct, provides some justification for the use of a separate control chart for monitoring the standard deviation. When there is a change in the mean only, it is more likely the \overline{X} -chart will signal a change in the process than either the R- or S-chart. These results are shown in Chapter 4. Also if there is only an increase in the standard deviation it is shown in Chapter 4 both the R- and S-charts are more likely to signal a change in the process than the \overline{X} -chart.

The concept of a process being in-control is discussed by Shewhart (1931) in terms of "natural" and "assignable" causes of variability in the process. Basically, a natural cause of variability is variability in the quality of the product designed or built into the process. Assignable causes of variability are (theoretically) removable without having to redesign the production process. In this research, it is assumed the causes of variability in the process are reflected in the mean, μ , and standard deviation, , of the quality measure, X. When

only natural causes of variability are present, the values of these parameters are taken to be $\mu = \mu_0$ and $=_0$ and the process is considered to be in-control. A process not incontrol is referred to as an out-of-control process. Out-of-control can take place by either a shift in the mean or a shift in the standard deviation or both.

It is well known a shift in the standard deviation will have an effect on the distributions of the sample mean, range, and standard deviation. A shift in the mean will only effect the distribution of the sample mean. It is convenient to denote shifts in the mean relative to μ_0 and $_0$. These values are defined as $=(\mu - \mu_0)/(_0/\sqrt{n})$ and $= /_0$. The parameter is the change in the mean from μ_0 measured in units equivalent to $_0/\sqrt{n}$, where n is the size of the sample in which the sample statistics, \overline{X} , R, and S are based. The parameter represents change in the standard deviation, , relative to the in-control standard deviation, $_0$. In-control now corresponds to = 0 and = 1. The process is out-of-control if 0 or 1.

2.2 \overline{X} -, R-, and S- Charts

Again consider the quality measure X taken on the output of a repetitive production process. Information about the process is in the form of periodically observed independent random samples, $X_{t,1}, X_{t,2}, ..., X_{t,n}$ each of size n, where t = 1, 2, 3, For each sample, the sample mean, \overline{X}_t , is computed and plotted against the sample number t, with t = 1, 2, 3, The sample mean is defined by

$$\overline{\mathbf{X}}_{t} = \frac{1}{n} \prod_{i=1}^{n} \mathbf{X}_{t,i}.$$

Under the assumption sampling is from a normal distribution, the sample mean has a normal distribution with mean, μ , and standard deviation, \sqrt{n} . Even if the assumption of a normal population does not hold and n is "large," the distribution of the sample mean

is approximately normal. This follows from the Central Limit Theorem. Burr (1967) found little difference in the properties of control charts based on the usually normal theory and their actual properties for various non-normal distributions. Schilling and Nelson (1976) studied control charts when the population was non-normal. For samples sizes of four or five, they found control charts based on normal theory perform about the same under a normal population as under various non-normal distributions.

If $X_{t,1}, X_{t,2}, \dots, X_{t,n}$ are independent and identically distributed random variables (a random sample) from a normal distribution with mean, μ , and standard deviation, , it follows

$$P[\mu_0 + a\frac{0}{\sqrt{n}} < \overline{X}_t < \mu_0 + b\frac{0}{\sqrt{n}}] = \frac{b-1}{2} - \frac{a-1}{2}$$
(2.1)

where (.) is the cumulative distribution function of a standard normal distribution. The value $\frac{b-}{\sqrt{n}} - \frac{a-}{\sqrt{n}}$ is the probability the sample mean falls in the interval $\mu_0 + a \frac{0}{\sqrt{n}}, \mu_0 + b \frac{0}{\sqrt{n}}$. Thus $1 - \frac{b-}{\sqrt{n}} + \frac{a-}{\sqrt{n}}$ is the probability the sample mean will fall outside this interval. As an example, for = 0, = 1, a = -3, b = +3

$$(+3) - (-3) = 0.99865 - 0.00135 = 0.99730.$$

Thus, the probability the mean of a sample taken from an in-control process falls more than three standard errors, $/\sqrt{n}$, from the in-control mean, μ_0 , is 1-0.99730 = 0.0027. Hence, it is not very probable the sample mean will be more than three standard errors from the in-control mean and if this occurs this is taken as evidence against the hypothesis of an in-control process. With this in mind, Shewhart (1931) recommended placing, what he referred to as action lines or control limits, on the plot of the sample means against the sample number. The action lines are the horizontal lines drawn at the points, $\mu_0 - 3(_0/\sqrt{n})$ and $\mu_0 + 3(_0/\sqrt{n})$, on the vertical axis. As their name implies, a value of the sample mean falling outside these limits is a signal some corrective action to the process may need to be taken. Also, a horizontal center line is usually drawn at the point μ_0 on the vertical axis.

The value b = -a = 3 is often used because Shewhart (1931) used it in various illustrations. This can be compared to the use of 5% for a level of significance following from comments made by Fisher (1932). It is common among the British to use b = -a = 3.09, since this would cause a signal on the average about one in five hundred times if the process is in-control. Control limits such as $\mu_0 - 3(\ _0/\sqrt{n})$ and $\mu_0 + 3(\ _0/\sqrt{n})$, are often referred to, respectively, as the lower control limit (LCL) and upper control limit (UCL).

Similarly the sample range, R_t , or the sample standard deviation, S_t , is also computed and plotted. The sample range is computed using

$$\mathbf{R}_{t} = \max\{\mathbf{X}_{t,1}, \mathbf{X}_{t,2}, \dots, \mathbf{X}_{t,n}\} - \min\{\mathbf{X}_{t,1}, \mathbf{X}_{t,2}, \dots, \mathbf{X}_{t,n}\}$$

The standardize range, W_t , is defined to be $R_t / ...$ The distribution of the standardized range is described by Harter (1960). He gives tables of percentage points and moments for the standardize range based on samples from a normal population. A FORTRAN program to compute the cumulative distribution of the standardized range is given by Barnard (1978). These tables can be used to obtain the percentage points and moments of the distribution of any sample range based on a sample from a normal distribution as a function of the standard deviation, . Since $R_t = W_t$, then $E[R_t] = E[W_t]$, $V[R_t] = {}^2V[W_t]$ and R = W, where R and W are the th percentage points, respectively, of the range and standardize range distributions. Commonly the notation $d_2 = E[W_t]$ and

 $d_3^2 = V[W_t]$ is used. Harter (1960) gives the values for d_2 and d_3^2 for n = 1(1)50. The center line and the lower and upper control limits as recommended in Montgomery (1991) are

LCL =
$$(d_2 - 3d_3)_0$$

CL = d_2_0
UCL = $(d_2 + 3d_3)_0$,

where LCL is chosen to be zero if $d_2 - 3d_3$ is less than zero. The lower and upper control limits can be chosen so that $P[R_t < LCL] = {}_1$ and $P[R_t > UCL] = {}_2$ with ${}_1 + {}_2 = {}_2$. Thus, LCL is R ${}_1$ and the UCL is R ${}_{1-2}$.

Suppose a sample size of n = 5 is to be used with $_{0}$ = 2. From Table 2 in Harter (1960), we find d₂ = 2.3259239473 and d₃² = 0.7466376009. Using the FORTRAN program given in Barnard (1978) (modified to perform calculations in double precision), the 2.5 and 97.5 percentage points of a standardized range were found to be R_{0.025} = 0.84967 and R_{0.975} = 4.19703. Thus, the center line and control limits for this chart are given by LCL = 3.1835, CL = 4.6518, and UCL = 11.9050 (rounded to four decimal places).

The sample standard deviation is defined by

$$\mathbf{S}_{t} = \sqrt{\frac{\prod_{i=1}^{n} \left(\mathbf{X}_{t,i} - \overline{\mathbf{X}}_{t} \right)^{2}}{n-1}}$$

The sample standard deviation is a biased estimator of with $E[S_t] = c_4$, where c_4 is a function of n and is given by

$$c_4 = \sqrt{\frac{2}{n-1}} \frac{\frac{n}{2}}{\frac{n-1}{2}}$$

The standard deviation of the sample standard deviation, S_t , is given by $\sqrt{1-c_4^2}$. A Shewhart chart based on the sample standard deviation is defined by

LCL =
$$\left(c_4 - 3\sqrt{1 - c_4^2}\right)_0$$

CL = c_4_0
UCL = $\left(c_4 + 3\sqrt{1 - c_4^2}\right)_0$

An S-chart based on probability limits would have LCL as S $_{_1}$ and the UCL is S $_{1-_2}\,$, where

$$\mathbf{S} = \sqrt{\frac{\frac{2}{n-1}}{n-1}} \quad \mathbf{0}$$

with ${}^{2}_{n-1}$, the th percentage point of a chi square distribution with n-1 degrees of freedom. Under the assumption sampling is from a normal distribution, it is a well-known fact the sample mean, \overline{X}_{t} , and sample standard deviation, S_{t} , are independent (see Bain and Engelhardt (1992)). A proof is given in Burroughs (1993) of the independence of the sample mean and range based on a random sample from a normal distribution.

Although little efficiency is lost by using the sample range as an estimator of the variability instead of the sample standard deviation of small sample sizes, this efficiency becomes more noticeable for n 10. To see this, we first consider the two unbiased estimators, R/d_2 and S/c_4 , of C_4 . The variances of these two estimators are given by

 $V[R/d_2] = (d_3^2/d_2^2)^2$ and $V[S/c_4] = [(1-c_4^2)/c_4^2]^2$. For each sample size, n = 2(1)25, Table 2.1 gives the values of the constants d_3^2/d_2^2 and $(1-c_4^2)/c_4^2$. Further, the relative efficiency, $re(R/d_2, S/c_4) = V[S/c_4] / V[R/d_2]$, of R/d_2 to S/c_4 is also tabulated.

TABLE 2.1. Relative Efficiency of R/d_2 and S/c_4 .			
n	d_3^2/d_2^2	$(1-c_4^2)/c_4^2$	$re(R/d_2, S/c_4)$
2	0.570796	0.570796	1.000000
3	0.275482	0.273240	0.991860
4	0.182628	0.178097	0.975189
5	0.138012	0.131768	0.954761
6	0.111964	0.104466	0.933035
7	0.094924	0.086498	0.911231
8	0.082911	0.073787	0.889947
9	0.073982	0.064324	0.869463
10	0.067077	0.057009	0.849897
11	0.061573	0.051185	0.831280
12	0.057078	0.046439	0.813597
13	0.053334	0.042497	0.796810
14	0.050164	0.039172	0.780872
15	0.047443	0.036328	0.765731
16	0.045079	0.033870	0.751333
17	0.043006	0.031723	0.737629
18	0.041171	0.029831	0.724570
19	0.039534	0.028153	0.712111
20	0.038064	0.026653	0.700211
21	0.036735	0.025304	0.688832
22	0.035528	0.024086	0.677938
23	0.034426	0.022980	0.667497
24	0.033416	0.021970	0.657480
25	0.032485	0.021046	0.647860

2.3 Estimators for μ_0 **and** $_0$

If target values for μ_0 and $_0$ are not given for a process, they must be estimated. The usual procedure is to base these estimates on a preliminary set of samples believed to be taken from a process when only natural causes of variability are present.

Consider the m independent random samples each of size, n, $X_{t,1}, X_{t,2}, ..., X_{t,n}$ from a normal distribution with mean, μ_0 and standard deviation, $_0$, t = 1, 2, ..., m. The estimator commonly recommended in the literature for μ_0 is

$$\overline{\overline{X}} = \frac{1}{m} \prod_{i=1}^{m} \overline{X}_{i} .$$

This estimator is an unbiased estimator of μ_0 with standard error given by $_0/\sqrt{mn}$. Three other possible estimators for μ_0 are the average of the sample medians, midranges, and trimmed means.

Possible estimators for μ_0 are

$$\overline{R} = \frac{1}{m} \prod_{i=1}^{m} R_i$$
 (average of the sample ranges);

$$\bar{S} = \frac{1}{m} \prod_{i=1}^{m} S_i$$
 (average of the sample standard deviations);

$$\overline{V}^{\mu_2} = \sqrt{\frac{1}{m}} \sum_{i=1}^{m} S_i^2$$
 (root of the average of the sample variances); and

$$\overline{MR} = \frac{1}{m} \frac{\prod_{j=2}^{n} |X_{t,j-1} - X_{t,j}|}{n-1} \text{ (average of the moving ranges)}$$

Each of these estimators are biased estimators of $_0$. Dividing each by the appropriate function of m and n yields unbiased estimators of $_0$. These estimators are \overline{R}/d_2 , \overline{S}/c_4 , $\overline{V}^{4/2}/c_{4,m(n-1)}$, and \overline{MR}/d_2 , where d_2 and c_4 are described in Section 2.2 and

$$c_{4,m(n-1)} = \sqrt{\frac{2}{m(n-1)}} \frac{\frac{m(n-1)+1}{2}}{\frac{m(n-1)}{2}}$$

Burroughs (1993) shows under the assumptions of normality and independent random samples,

$$V[\overline{V}^{\nu^2}/c_{4,m(n-1)}] \quad V[\overline{S}/c_4] \quad V[\overline{MR}/d_2] \quad V[\overline{R}/d_2].$$

Hence, the estimator, $\overline{V}^{1/2}/c_{4,m(n-1)}$, is the most efficient estimator of $_0$ under these assumptions.

2.4 Supplementary Runs Rules

In order to make a Shewhart chart more sensitive to small shifts in the mean, runs rules have been recommended. A runs rule causes the chart to signal if k out of the last m plotted statistics, Y, fall in the interval between $E[Y] + a \sqrt{V[Y]}$ and $E[Y] + b \sqrt{V[Y]}$, a < b. Runs rules suggested for the \overline{X} -chart are given in the Western Electric Handbook (1956). These rules are listed in Table 2.4.1. As with the \overline{X} -chart, supplementary runs rules can be used with the R-chart and the S-chart. Runs rules for the R-chart, see Table 2.4.2, are suggested in the Western Electric Handbook (1956). Note these rules are also expressed in terms of the standardized values of the plotted statistic. For example, the rule T(2,2,+2,+3) used with the R-chart is interpreted to mean a signal is given if 2 out of the last 2 sample ranges were between +2 and +3 standard errors above the in-control mean of the sampling distribution of the range. These rules or rules used with the \overline{X} - chart may be applied to the S-chart. Champ, Lowry, and Woodall (1992) suggest some alternate rules for both the R- and S- charts.

Using rules to detect assignable causes of variability are discussed in the Western Electric Handbook (1956). Nelson (1984,1985) gives discussions on the use of runs rules for detecting an out-of-control process.

TABLE 2.4.1. Suggested Runs Rules for the \overline{X} -chart		
1. T(1,1,+3,+)	5. T(8,8,-3,0)	
2. T(2,2,+2,+3)	6. T(4,5,-3,-1)	
3. T(4,5,+1,+3)	7. T(2,3,-3,-2)	
4. T(8,8,0,+3)	8. T(1,1,- ,3)	

TABLE 2.4.2. Suggested Runs Rules for the R-Chart			
1. T(1,1,+3,+)	5. T(10,10,-3,0)		
2. T(2,2,+2,+3)	6. T(6,6,-3,-1)		
3. T(3,3,+1,+3)	7. T(4,4,-3,-2)		
4. T(7,7,0,+3)	8. T(1,1,- ,-3)		

2.5 Other Simultaneous Mean and Variability Charts

As pointed out by Jennett and Welch (1939), a change in either the mean or the standard deviation of a process would alter the proportion defective articles being produced

when goods are being manufactured to a specification. They suggest a monitoring scheme which plots the statistic (U - \overline{X})/S. The value, U, is an upper tolerance limit for the quality measure, X. If ease of calculations is needed, they suggest the scheme based on the statistic (U - \overline{X})/W, where W is an easily calculated estimator of the standard deviation such as the sample range.

Page (1955) considered using a single chart when changes in the standard deviation are relatively rare or unimportant. He suggested a set of runs rules for the \overline{X} -chart each of which was designed to detect a shift in the mean or variance. The runs rules he considered cause a signal if

(1)
$$T(1,1,-,-b)$$
 or $T(1,1,b,)$; or

(2) T(m,m,-b,-a) or T(m,m,a,b), a < b; or

(3) two out of the last m plotted statistics fall outside opposite warning lines.

The runs rules in (1) and (2) are used to detect an increase or decrease in the mean and the one in (3) would be useful in detecting an increase in the standard deviation. Page (1955) further suggested applying a runs rule of the form T(m,m,-a,a) for detecting a decrease in the process standard deviation. He did not consider this rule in his analysis of the \overline{X} -chart supplemented with runs rules.

Chengalur, Arnold, and Reynolds (1989) investigated two control charting procedures monitoring both the mean and variance or standard deviation of a normal (population) distribution. One was the use of separate charts. They considered the \overline{X} -chart to monitor the mean and the S²- chart to monitor the variance. The second procedure was based on the statistic proposed by Reynolds and Ghosh (1981). In each case the charts are modified to use variable sampling intervals. As they pointed out, the problem of monitoring both μ and ² is analogous to the problem of simultaneously monitoring both the mean and variance. The hypothesis to be tested are

$$H_{0}: \mu = \mu_{0} \text{ and } {}^{2} = {}^{2}_{0}$$

$$H_{a}: \mu \mu_{0} \text{ or } {}^{2} {}^{2}_{0} \qquad (2.4.1)$$

or

$$H_{0}: \mu = \mu_{0} \text{ and } ^{2} = {}^{2}_{0}$$

$$H_{a}: \mu \mu_{0} \text{ or } ^{2} > {}^{2}_{0}$$
(2.4.2)

Their paper concentrated on the hypothesis (2.4.2).

The test statistic used to test $H_0: \mu = \mu_0$ and $^2 = ^2_0$ verses $H_a: \mu \mu_0$ or $^2 > ^2_0$ was proposed by Reynolds and Ghosh (1981). It is based on the squared standardized deviations of the observations from the target value μ_0 and has the form

$$\mathbf{Y}_{t} = \prod_{j=1}^{n} \frac{\mathbf{X}_{t,j} - \mu_{0}}{0}^{2}$$

where t is the sample number with t = 1,2,3, ... The null distribution of Y_t is a chi square distribution with n degrees of freedom. When $\mu = \mu_0$ the test rejecting H_0 when $Y_t = \frac{2}{n,1-}$ is uniformly most powerful for detecting increases in $\frac{2}{n}$. The value $\frac{2}{n,1-}$ is the (1 - th) percentage point of a chi square distribution with n degrees of freedom. In general, this test is quite good at detecting changes in $\frac{2}{n}$.

The expected value of Y_t is n if the null hypothesis holds and is given by

$$E[Y_t] = \frac{n^2}{\frac{2}{0}} + \frac{\mu - \mu_0}{\frac{2}{0}/\sqrt{n}}^2$$

if the alternative hypothesis holds. Under the assumption H_0 holds, the variance of Y_t is 2n. Hence, the control limits for this charting procedure are

$$LCL = {2 \atop n, 1}$$
$$CL = n$$
$$UCL = {2 \atop n, 1-2}$$

White and Schroeder (1987) proposed a simultaneous control chart using resistant measures and a modified box plot display. This chart while being used to control the process mean and variability also displays information about the distribution and specifications of the quality measure. One can view this charting procedure as a combined median, \tilde{X} , chart and a interquartile range, IQR = Q₃ - Q₁, chart, where Q₁ and Q₃ are, respectively, the lower and upper sample quartiles. White and Schroder (1987) refer to IQR as the Q-spread. Based on the assumption the population of quality measures has a normal distribution, the control limits for the \tilde{X} -chart are given by

LCL =
$$\tilde{X}_{n, -1} - r_1$$

CL = $E[\tilde{X}]$
UCL = $\tilde{X}_{n, 1} - r_1$

where $\tilde{X}_{n,}$ is the th percentage point of the distribution of the median. The control limits for the IQR-chart are given by

$$LCL = IQR_{n, 2-r_{2}}$$
$$CL = E[IQR]$$
$$UCL = IQR_{n,1-r_{2}}$$

where IQR_n is the th percentage point of the distribution of the inner quartile range. Teichroew (1956) tabulates values for expected values of order statistics and the products of order statistics from a standard normal distribution. These tabulations can be used to determine numeric values for the expectations and variances in the control limit formulas for the \tilde{X} -chart and the IQR-chart . For the lower and upper percentage points for both charts, White and Schroeder (1987) chose respectively, -3 and +3.

Since the distribution of the sample mean is a function of the standard deviation as well as the mean, the performance of the \overline{X} -chart is affected by a shift in the standard deviation as well as the mean. When a combined charting procedure gives a signal it would be useful if the chart causing the signal was also an indication of which parameter, μ or , had shifted. With this in mind, we propose separate charts based on the statistics, $T_t = (\overline{X}_t - \mu_0)/(S_t/\sqrt{n})$ and S_t . In general, the random variable, T_t , has a noncentral t-distribution with n-1 degrees of freedom and noncentrality parameter, / . The distribution of T_t has a central t-distribution if $\mu = \mu_0 (= 0)$. A Shewhart chart based on T_t is defined by

$$LCL = t_{2};$$

$$CL = 0$$

$$UCL = t_{1-1}$$

where t is the th percentage point of a central t-distribution with n-1 degrees of freedom.

As stated previously, the chart based on S_t is not affected by a change in the mean. The chart based on T_t is not affected by a change in if there is no change in μ . It is affected, though, if there is a change in both μ and but only through the ratio / . A relative large increase in the standard deviation relative to the shift in the mean would have only a small affect on the distribution of the statistic, T_t . On the other hand, this distribution would be affected by a relative large increase or decrease in the mean; or if the standard deviation decreases. A decrease in the standard deviation, although classified as an out-of-control condition, is associated with process improvement and needs to be detected. This condition would affect both the distributions of T_t and S_t possibility leading to a misinterpretation of a signal. It should be noted T_t and S_t are not independent.

In this section, we have reviewed some of the other proposed ways of monitoring the mean and variance simultaneously. In practice, as stated by Page (1955) and Chengular, Arnold, and Reynolds (1989), the typical approach is to use separate charts for each parameter and then to signal if either chart signals. Although this seems to be a reasonable approach, it may not be optimal for detecting certain types of process changes such as those involving a change in both μ and μ . The type of rectifying action to be taken and the changes likely to occur are important to consider before setting up any of these schemes. If a different rectifying action must be taken for a change in the mean as for a change in the standard deviation, Page (1955) suggested the control charting procedure should indicate the type of change in the process and not just its existence. In this research, we concentrate on analyzing the performance of separate charts to control both the mean and standard deviation of a normal distribution. Since the charts commonly used to control the mean and standard deviation are, respectively, the \overline{X} -chart and R- (or S-) chart, we analyze these two charts as a simultaneous control charting procedure. This research will provide an analysis of what is commonly done in practice and provide a foundation for further comparison of simultaneous control charting procedures.

Chapter 3. EVALUATING THE RUN LENGTH DISTRIBUTION

3.1 Introduction

The run length of a quality control chart is the sample number in which the chart first gives a signal. Woodall and Ncube (1985) define the run length N of a multidimensional charting procedure as the minimum of $N_1, ..., N_p$, where N_j is the run length of the j^{th} chart monitoring the j^{th} component of the mean. Similarly, Champ (1986) defined the run length for the combined \overline{X} - and R- (or S-) charts as N = min { N_1, N_2 } where N_1 and N_2 are the run lengths of the \overline{X} - and R- (or S-) charts, respectively. Gan (1989) investigates the combined cumulative sum (CUSUM) mean chart and Shewhart variance chart, and the combined exponentially weighted moving average (EWMA) chart and Shewhart variance chart. He also defines the run length of these combined schemes as the minimum of the run lengths of the individual charts.

Various techniques have been used to evaluate the run length distribution of a control chart. Among these are the integral equation, Markov chain, and simulation methods. A procedure was developed by Champ and Woodall (1987) for representing a Shewhart chart supplemented with runs rules as a Markov chain. In this chapter, Champ and Woodall's (1987) method is used to develop procedures for evaluating the run length distribution of the combined \overline{X} - and R- (or S-) charts. The first of these methods uses Champ and Woodall's (1987) method to determine the run length distribution of the minimum run length from the run length distribution of the individual \overline{X} - and R- (or S-) charts. A modified version of Champ and Woodall's (1990) FORTRAN program was used to determine the run length distribution of the individual charts. The second method

determines the Markov chain representation of the combined chart from the Markov chain representation of the individual charts found in Champ and Woodall (1987). The FORTRAN program of Champ and Woodall (1990) was modified to obtain the Markov chain representation of the combined chart.

3.2 Combined Run Length Distributions Approach

Champ and Woodall (1987) gave a procedure for representing a Shewhart chart supplemented with runs rules as a Markov chain. The FORTRAN program by Champ and Woodall (1990) calculates the average run length (ARL) for a Shewhart \overline{X} -chart supplemented with runs rules for various standardized shifts in the mean. A modified version of this program was used by Lowry, Champ, and Woodall (1994) to calculate the ARL and percentage points of both the R- and S-charts supplemented with runs rules. The program by Champ and Woodall (1990) can be modified to obtain the cumulative distribution function (CDF) of the run length of the \overline{X} -, R-, or S-charts supplemented with runs rules.

Let N_1 and N_2 , respectively, denote the run lengths of the \overline{X} -chart and the R-chart (or S-chart). Further, denote the CDFs of N_1 and N_2 , respectively, by $F_1(t)$ and $F_2(t)$. The CDF of the run length, $N = \min\{N_1, N_2\}$, of the combined \overline{X} - and R- (or S-) chart is determined by

$$F_{N}(t) = P[N \ t]$$

$$= 1 - P[N > t]$$

$$= 1 - P[N_{1} > t, N_{2} > t]$$

$$= 1 - P[N_{1} > t] P[N_{2} > t]$$

$$= 1 - \{1 - P[N_{1} \ t]\}\{1 - P[N_{2} \ t]\}$$

$$= 1 - [1 - F_{1}(t)][1 - F_{2}(t)], \qquad (3.2.1)$$

t=1, 2, 3, The independence of N_1 and N_2 follows since \overline{X}_t and R_t (or S_t) are independent, t=1, 2, ... (see Chapter 2, Section 2.2).

It is convenient to define the function, $\overline{F}()$, by $\overline{F}(t)=1 - F(t)$, where F(t) is any CDF. Using this notation, we can express equation (3.2.1) as

$$\mathbf{F}_{\mathrm{N}}(t) = 1 - \mathbf{\overline{F}}_{1}(t) \mathbf{\overline{F}}_{2}(t)$$

or

$$\overline{F}_{N}(t) = \overline{F}_{1}(t) \overline{F}_{2}(t), \qquad (3.2.2)$$

t=1, 2, It follows from equations (3.2.1) and (3.2.2) the probability distribution function (pdf) of N can be expressed by

$$P(N = t) = [1 - F_1(t-1)][1 - F_2(t-1)] - [1 - F_1(t)][1 - F_2(t)]$$
(3.2.3)

or

$$P(N = t) = \bar{F}_{N}(t-1) - \bar{F}_{N}(t), \qquad (3.2.4)$$

for t=1,2, ... , where we define $F_1(0)=F_2(0)=0$.

As a special case, consider the basic Shewhart \overline{X} - and R- (or S-) charts, that is, each chart is defined by the set of runs rules {T(1,1,- ,-b_L), T(1,1,+b_U,+)}, where b_L and b_U are positive real numbers. It is well-known for this situation the run length, N_i, follows a geometric distribution with parameter p_i, the probability the chart signals at any sampling stage. The CDF of the run length N_i, as given in Bain and Engelhardt (1992), is $F_{N_i}(t) = 1 - q_i^t$, where $q_i = 1 - p_i$, i=1,2. From equation (3.2.1), we see the CDF of the minimum is $F_N(t) = 1 - (q_1q_2)^t$. It follows the run length, N, of the combined chart follows a geometric distribution with parameter p = $1 - q_1q_2$.

Various parameters of the run length are of interest. These include, among others, the mean, standard deviation, and percentage points of the run length. The mean is often referred to as the average run length (ARL). These parameters of the run length distribution of the combined Shewhart \overline{X} - and R- (or S-) charts are given by

$$\mu_{\rm N} = {\rm E}[{\rm N}] = \frac{1}{1 - q_1 q_2}, \qquad (3.2.5)$$

$$_{\rm N} = \frac{\sqrt{q_1 q_2}}{1 - q_1 q_2}$$
, and (3.2.6)

$$N = \frac{\log(1 - 1)}{\log(q_1 q_2)} , \qquad (3.2.7)$$

where N is the th percentage point and is the ceiling function. A discussion of the derivation of the mean and standard deviation of a geometric distribution is given in Bain and Engelhardt (1992). The th percentage point is defined to be the smallest integer, N, such that P[N N] . It follows P[N N]=1 - P[N > N]=1 - $(q_1q_2)^N = .$ Solving this equation for the integer, N, under the given condition it is the smallest integer such that P[N N] yields equation (3.2.7).

These parameters of the minimum run length can be expressed in terms of the average run lengths, $E[N_1]$ and $E[N_2]$. Noting $E[N_i]=1/(1-q_i)$, for i=1, 2, these expressions are

$$\mu_{N} = E[N] = \frac{E[N_{1}]E[N_{2}]}{E[N_{1}] + E[N_{2}] - 1},$$
(3.2.8)

$$_{N} = \sqrt{\frac{(E[N_{1}] - 1)(E[N_{2}] - 1)}{E[N_{1}] + E[N_{2}] - 1}},$$
(3.2.9)

and

$$N = \frac{\log(1 - 1)}{\log \frac{(E[N_1] - 1)(E[N_2] - 1)}{E[N_1]E[N_2]}},$$
(3.2.10)

If supplementary runs rules are applied individually to the \overline{X} -chart and the R-chart (or S-chart), the Markov chain approach of Champ and Woodall (1987) can be used to determine the run length properties of N₁ and N₂. Hence, the run length properties of N can be determined. As stated previously, the FORTRAN program of Champ and Woodall (1990) can be modified to obtain the CDF's of N₁ and N₂ for any value of t, t=1, 2, 3, The CDF of N can then be determined for each t using either equation (3.2.1) or (3.2.2).

Although the values of the CDFs of N_1 and N_2 for each t can be obtained theoretically using the Markov chain approach, it may not be practical to obtain their values for large values of t. Woodall (1983) showed as t gets larger the tail probabilities, $P(N_i=t)$, i=1, 2, can be approximated by a geometric distribution. For large t, say for t greater than some value t_i^* he shows there exists a _____i such that this approximation takes the form

$$P(N_{i} = t_{i}^{*} + k) \qquad {}^{k}_{i} P(N_{i} = t_{i}^{*}), \qquad (3.2.11)$$

i=1, 2 and k=1, 2, Woodall (1983) gave two approximation for i,

$$\hat{n}_{i} = \frac{P(N_{i} = t_{i}^{*})}{P(N_{i} = t_{i}^{*} - 1)}$$
(3.2.12)

and

$$_{i} = \frac{1 - \prod_{t=1}^{t_{i}^{*}} P(N_{i} = t)}{1 - \prod_{t=1}^{t_{i}^{*} - 1} P(N_{i} = t)}$$
(3.2.13)

Woodall (1983) suggested using the values of \hat{i}_i and \hat{i}_i to determine the value of t_i^* . For each t, determine the approximations \hat{i}_i and \hat{i}_i for \hat{i}_i and choose $t_i^*=t$ if these approximations are close, say $|\hat{i}_i - i| < t$ for small. The values of \hat{i}_i , \hat{i}_i and t_i^* , can be determined with a modification to the FORTRAN program of Champ and Woodall (1990).

The CDF of the run length, N_i , now can be determined exactly for values of 1 t t_i^* . For the values of $t=t_i^* + k$ the CDF of the run length, N_i , using equation (3.2.11) can be approximated by

$$F_i(t_i^* + k) = P[N_i \quad t_i^* + k]$$

$$= 1 - P[N_i > t_i^* + k]$$

$$= 1 - P[N_i = t_i^* + k + j]$$

$$1 - \frac{k+j}{j=1} P\left(N_i = t_i^*\right)$$

$$= 1 - \frac{\sum_{i=1}^{k+1} P[N_i = t_i^*]}{1 - \sum_{i=1}^{k} P[N_i = t_i^*]}$$

$$=\frac{1-\frac{1-k+1}{i}P[N_{i}=t_{i}^{*}]}{1-\frac{1-k}{i}}$$

$$\overline{F}_{i}(t_{i}^{*}+k) = \frac{\frac{k+1}{1}}{1-i}P[N_{i}=t_{i}^{*}]$$
(3.2.14)

k=1, 2, 3, Equation (3.2.14) cannot be used directly to obtain an approximate value for $F_i(t_i^* + k)$, since __i is not known. Replacing __i in the right hand side of this expression with either $\hat{}_i$ or __i yields an obtainable approximation for $F_i(t_i^* + k)$. Woodall (1983) recommends the use of __i.

Wheeler (1983) evaluated the CDFs for various \overline{X} -charts supplemented with runs rules and for selected shifts in the mean of the process. He derived some closed formed expressions and used these expressions along with simulation to calculate tables of the CDFs for t=1(1)10. Using this same method, Coleman (1986) evaluated these charts and found an error in Wheeler's (1983) derivation of the CDF of the chart defined by the runs rules {T(1,1,3,), T(2,3,2,3), T(4,5,1,3)}.

For large ARLs, Woodall (1983) showed that

$$E(N_{i}) = \int_{t=1}^{t_{i}^{*}} t P[N_{i} = t] + i P[N_{i} = t_{i}^{*}] \left[\frac{t_{i}^{*}}{1 - i} + \frac{1}{(1 - i)^{2}}\right]$$
(3.2.15)

and

$$E(N_{i}^{2}) = \int_{t=1}^{t_{i}^{*}} t^{2} P[N_{i} = t] + \int_{i} P[N_{i} = t_{i}^{*}] \left[\frac{(t_{i}^{*})^{2}}{1 - i} + \frac{2t_{i}^{*} - 1}{(1 - i)^{2}} + \frac{2}{(1 - i)^{3}}\right]. \quad (3.2.16)$$

Further he showed the t^{th} percentage point, N , can be approximated by

$$N_{i,} = t_{i}^{*} - 1 + \ln[(1 - t_{i}) \frac{t - 1}{P[N_{i} = t_{i}^{*}]} + t_{i}] / \ln(t_{i})$$
(3.2.17)

Note, the value of $N_{i,}$ should be determined exactly for $F_i(t_i^*)$ by searching for the value $N_{i,}$ such that $F_i(N_{i,} -1) < \text{ and } F_i(N_{i,})$.

We now consider the geometric approximation of the tail probabilities for the run length distribution of the combined Shewhart \overline{X} - and R- (or S-) charts supplemented with runs rules. Assuming t_1^* t_2^* , the values of the CDFs of N₁ and N₂ are determined exactly using Champ and Woodall's (1987) procedure for t=1, 2, ... t_1^* . The CDF of N is then determined exactly by applying equation (3.2.1) for t=1, 2, ... t_1^* . For t= t_i^* +1, ... , t_2^* , the CDF of N can be determined approximately by

$$F_{N}(t_{i}^{*}+k) = 1 - \frac{\sum_{i=1}^{k+1} P[N_{i} = t_{i}^{*}] \left(1 - F_{2}(t_{i}^{*}+k)\right)$$

$$= 1 - \frac{\sum_{i=1}^{k+1} P[N_i = t_i^*] \overline{F}_2(t_i^* + k)$$

or

$$\overline{F}_{N}(t_{i}^{*}+k) = \frac{\frac{k+1}{i}}{1-\frac{1}{i}}P[N_{i}=t_{i}^{*}]\overline{F}_{2}(t_{i}^{*}+k)$$
(3.2.18)

for k=1, ..., $t_2^* - t_1^*$. For t= $t_2^* + 1, t_2^* + 2, ...$, or k=1, 2, 3, ..., the CDF becomes

$$F_{N}(t_{2}^{*}+k) = 1 - \frac{t_{2}^{*}-t_{1}^{*}+k+1}{1-1}P[N_{1}=t_{1}^{*}] = \frac{k+1}{1-2}P[N_{2}=t_{2}^{*}]$$

$$=1-\frac{\frac{t_{2}^{*}-t_{1}^{*}+k+1}{2}P[N_{1}=t_{1}^{*}]P[N_{2}=t_{2}^{*}]}{(1-t_{1})(1-t_{2})}P[N_{1}=t_{1}^{*}]P[N_{2}=t_{2}^{*}]$$

or

$$\overline{F}_{N}(t_{2}^{*}+k) = 1 - \frac{t_{2}^{*}-t_{1}^{*}+k+1}{(1-t_{1})(1-t_{2})} P[N_{1} = t_{1}^{*}]P[N_{2} = t_{2}^{*}].$$
(3.2.19)

For the case where $t_1^* = t_2^*$, equation (3.2.19) becomes

$$F_{N}(t_{2}^{*}+k) = 1 - \frac{\binom{1}{2}^{k+1}}{\binom{1}{1-1}(1-2)} P[N_{1} = t_{1}^{*}]P[N_{2} = t_{2}^{*}],$$

or

$$\overline{F}_{N}(t_{2}^{*}+k) = \frac{\binom{1}{1-2}^{k+1}}{\binom{1-1}{1-2}} P[N_{1} = t_{1}^{*}]P[N_{2} = t_{2}^{*}].$$
(3.2.20)

For the case where $t_1^* = t_2^*$, $\overline{F}_N(t)$ is determined exactly using equation (3.2.2), for t=1,2, ..., t_2^* . The value of $\overline{F}_N(t_2^* + k)$ is approximated by

$$\overline{F}_{N}(t_{2}^{*}+k) = \frac{\frac{k+1}{2}}{1-\frac{1}{2}}\overline{F}_{1}(t_{2}^{*}+k)P[N_{2}=t_{2}^{*}], \qquad (3.2.21)$$

for k=1, 2, ... , \boldsymbol{t}_1^* - \boldsymbol{t}_2^* ; and approximated by

$$\overline{F}_{N}(t_{1}^{*}+k) = \frac{k+1}{(1-1)} \frac{t_{1}^{*}-t_{2}^{*}+k+1}{(1-1)} P[N_{1} = t_{1}^{*}]P[N_{2} = t_{2}^{*}], \qquad (3.2.22)$$

for $k = t_1^* - t_2^* + 1$, $t_1^* - t_2^*, +2, \dots$.

These tail approximations can now be used to obtain approximations for the mean, E[N], the variance, V[N], and the th percentage points, N , of the combined run length distribution. The approximation to E[N] is derived in what follows. Assuming t_1^* t_2^* ,

$$E[N] = \lim_{t=1} t P[N = t]$$
$$= \Pr[N > t]$$

$$= \prod_{i=0}^{t_{1}} P[N_{1} > t] P[N_{2} > t]$$

$$= \prod_{i=0}^{t_{1}^{i}} \overline{F}_{1}(t)\overline{F}_{2}(t) + \prod_{i=t_{1}^{i}+1}^{t_{2}^{i}} \overline{F}_{1}(t)\overline{F}_{2}(t) + \prod_{i=t_{2}^{i}+1}^{t_{1}} \overline{F}_{1}(t)\overline{F}_{2}(t)$$

$$= \prod_{i=0}^{t_{1}^{i}} \overline{F}_{1}(t)\overline{F}_{2}(t) + \prod_{i=1}^{t_{2}^{i}-t_{1}^{i}} \overline{F}_{1}(t_{1}^{*} + t)\overline{F}_{2}(t_{1}^{*} + t) + \prod_{i=1}^{i} \overline{F}_{1}(t_{1}^{*} + t_{2}^{*} - t_{1}^{*} + t)\overline{F}_{2}(t_{2}^{*} + t)$$

$$= \prod_{i=0}^{t_{1}^{i}} \overline{F}_{1}(t)\overline{F}_{2}(t) + \frac{1}{1-1} \prod_{i=1}^{t_{1}^{i}} \overline{F}_{2}(t_{1}^{*} + t) + \prod_{i=1}^{i} \overline{F}_{1}(t_{1}^{*} + t_{2}^{*} - t_{1}^{*} + t)\overline{F}_{2}(t_{2}^{*} + t)$$

$$= \prod_{i=0}^{t_{1}^{i}} \overline{F}_{1}(t)\overline{F}_{2}(t) + \frac{1}{1-1} \prod_{i=1}^{t_{1}^{i}} \overline{F}_{2}(t_{1}^{*} + t)$$

$$= \prod_{i=0}^{t_{1}^{i}} \overline{F}_{1}(t)\overline{F}_{2}(t) + \frac{1}{1-1} \prod_{i=1}^{t_{1}^{i}} \overline{F}_{2}(t_{1}^{*} + t)$$

$$= \prod_{i=0}^{t_{1}^{i}} \overline{F}_{1}(t)\overline{F}_{2}(t) + \frac{1}{1-1} \prod_{i=1}^{t_{1}^{i}} \overline{F}_{2}(t_{1}^{*} + t)$$

$$= \prod_{i=0}^{t_{1}^{i}} \overline{F}_{1}(t)\overline{F}_{2}(t_{1}^{*}) + \frac{1}{1-1} \prod_{i=1}^{t_{2}^{i}-t_{1}^{*}} \overline{F}_{2}(t_{1}^{*} + t)$$

$$= \prod_{i=0}^{t_{1}^{i}} \overline{F}_{1}(t)\overline{F}_{2}(t_{2}^{*}) + \frac{1}{(1-1)} \prod_{i=1}^{t_{2}^{i}-t_{1}^{*}} \overline{F}_{2}(t_{1}^{*} + t)$$

$$= \prod_{i=0}^{t_{1}^{i}} \overline{F}_{1}(t)\overline{F}_{2}(t_{2}^{*}) + \frac{1}{(1-1)} \prod_{i=1}^{t_{2}^{i}-t_{1}^{*}} \overline{F}_{2}(t_{1}^{*} + t)$$

$$= \prod_{i=0}^{t_{1}^{i}} \overline{F}_{1}(t)\overline{F}_{2}(t_{2}^{*}) + \frac{1}{(1-1)} \prod_{i=1}^{t_{2}^{i}-t_{1}^{*}} \overline{F}_{2}(t_{1}^{*} + t)$$

$$= \prod_{i=0}^{t_{1}^{i}} \overline{F}_{1}(t)\overline{F}_{2}(t_{2}^{*}) + \frac{1}{(1-1)} \prod_{i=1}^{t_{2}^{i}-t_{1}^{*}} \overline{F}_{2}(t_{1}^{*} + t)$$

$$= \prod_{i=0}^{t_{1}^{i}} \overline{F}_{1}(t)\overline{F}_{2}(t_{2}^{*}) + \frac{1}{(1-1)} \prod_{i=1}^{t_{2}^{i}-t_{i}^{*}} \overline{F}_{1}(t) - \frac{1}{(1-1)} \prod_{i=1}^{t_{i}^{i}-t_{i}^{*}} \overline{F}_{1}(t) - \frac{1}{(1-1)} \overline{F}_{2}(t) - \frac{1}{(1-1)} \overline{F}_{2$$

For the case where $t_1^* = t_2^*$, we have

$$E[N] \quad \sum_{t=0}^{t_{2}^{*}} \overline{F}_{1}(t)\overline{F}_{2}(t) + \frac{2f_{2}(t_{2}^{*})}{1-2} \sum_{t=1}^{t_{1}^{*}-t_{2}^{*}} \frac{1}{2} \overline{F}_{1}(t_{2}^{*}+t) + f_{1}(t_{1}^{*})f_{2}(t_{2}^{*}) \frac{1-2}{(1-1)(1-2)(1-1)} .$$

$$(3.2.24)$$

It is well-known $V[N]=E[N^2] - (E[N])^2$. From this equation, in order to determine an approximation for V[N], we need only find an approximation for the value $E[N^2]$. An approximation for $E[N^2]$ is derived in what follows.

$$\begin{split} E[N^{2}] &= \underset{t=1}{t^{2}} t^{2} P[N = t] \\ &= \underset{t=0}{t^{2}} (2t + 1) P[N > t] \\ &= 2 \underset{t=1}{t^{2}} t P[N > t] + \underset{t=0}{t^{2}} P[N > t] \\ &= 2 \underset{t=1}{t^{1}} t \overline{F}_{1}(t) \overline{F}_{2}(t) + \underset{t=1}{t^{2}} t \overline{F}_{1}(t) \overline{F}_{2}(t) + \underset{t=1}{t^{2}} t \overline{F}_{1}(t) \overline{F}_{2}(t) + E[N] \\ &= 2 \underset{t=1}{t^{1}} t \overline{F}_{1}(t) \overline{F}_{2}(t) + \underset{t=1}{t^{2}} t \overline{F}_{1}(t) \overline{F}_{2}(t) + E[N] \\ &= 2 \underset{t=1}{t^{1}} t \overline{F}_{1}(t) \overline{F}_{2}(t) + \underset{t=1}{t^{2}} t \overline{F}_{1}(t) \overline{F}_{2}(t) + E[N] \\ &+ \underset{t=1}{t^{2}} t \overline{F}_{1}(t) \overline{F}_{2}(t) + \underset{t=1}{t^{2}} t \overline{F}_{2}(t^{2}_{2} + t) + E[N] \\ &+ \underset{t=1}{t^{1}} t \overline{F}_{1}(t) \overline{F}_{2}(t) + \underset{t=1}{t^{2}} t \overline{F}_{1}(t^{2}_{1} + t) \overline{F}_{2}(t^{2}_{1} + t) \\ &+ \underset{t=1}{t^{2}} t \overline{F}_{1}(t) \overline{F}_{2}(t) + \underset{t=1}{t^{2}} t \overline{F}_{1}(t^{2}_{1} + t) + E[N] \\ &= 2 \underset{t=1}{t^{1}} t \overline{F}_{1}(t) \overline{F}_{2}(t) + \underset{t=1}{t^{2}} t \overline{F}_{1}(t^{2}_{1} + t) + E[N] \\ &= 2 \underset{t=1}{t^{1}} t \overline{F}_{1}(t) \overline{F}_{2}(t) + \underset{t=1}{t^{2}} t \overline{F}_{1}(t^{2}_{1} + t) + E[N] \\ &= 2 \underset{t=1}{t^{1}} t \overline{F}_{1}(t) \overline{F}_{2}(t) + \underset{t=1}{t^{2}} t \overline{F}_{1}(t^{2}_{1} + t) + \underbrace{F}_{1}(t^{2}_{1} + t) \\ &= 2 \underset{t=1}{t^{1}} t \overline{F}_{1}(t) \overline{F}_{2}(t) + \underset{t=1}{t^{2}} t \overline{F}_{1}(t^{2}_{1} + t^{2}_{1} + t^{2}_{1} + t) \\ &= 2 \underset{t=1}{t^{1}} t \overline{F}_{1}(t) \overline{F}_{2}(t) + \underset{t=1}{t^{2}} t \overline{F}_{1}(t^{2}_{1} + t^{2}_{1} \\ &= 2 \underset{t=1}{t^{1}} t \overline{F}_{1}(t) \overline{F}_{2}(t) + \underset{t=1}{t^{2}} t \overline{F}_{1}(t^{2}_{1} + t^{2}_{1} \\ &= 2 \underset{t=1}{t^{1}} t \overline{F}_{1}(t) \overline{F}_{2}(t) + \underset{t=1}{t^{2}} t \underbrace{F}_{1} t \underbrace{F}_{1}(t) \underbrace{F}_{1}(t) + \underset{t=1}{t^{2}} t \underbrace{F}_{1}(t) + \underset{t=1}{t^{2}} t \underbrace{F}_{1}(t) +$$

$$+ \frac{f_{1}(t_{1}^{*})}{1 - \frac{1}{1 - 1}} t_{1}^{*1} t_{1}^{*1} \overline{F}_{2}(t_{1}^{*} + t)$$

$$+ \frac{t_{2}^{*} t_{1}^{*2} t_{1}^{*}}{(1 - \frac{1}{1})(1 - \frac{1}{2})} f_{1}(t_{1}^{*}) f_{2}(t_{2}^{*}) t_{1}^{*1} (t_{1}^{*}) f_{2}(t_{2}^{*}) t_{1}^{*1} + E[N]$$

$$+ \frac{t_{2}^{*} t_{1}^{*2} t_{1}^{*}}{(1 - \frac{1}{1})(1 - \frac{1}{2})} f_{1}(t_{1}^{*}) f_{2}(t_{2}^{*}) t_{1}^{*1} t_{1}^{*1} \overline{F}_{2}(t_{1}^{*} + t)$$

$$= 2 t_{1}^{*1} t\overline{F}_{1}(t)\overline{F}_{2}(t) + \frac{t_{1}^{*} f_{1}(t_{1}^{*})}{1 - \frac{1}{1 - 1}} t_{1}^{*2} t_{1}^{*1} \overline{F}_{2}(t_{1}^{*} + t)$$

$$+ \frac{f_{1}(t_{1}^{*})}{1 - \frac{1}{1 - 1}} t_{1}^{*2} t_{1}^{*1} \overline{F}_{2}(t_{1}^{*} + t)$$

$$+ \frac{t_{2}^{*} t_{1}^{*2} t_{1}^{*1} (t_{1} - \frac{1}{2})^{2}}{(1 - t_{1})(1 - t_{2})(1 - t_{1} - t_{2})} f_{1}(t_{1}^{*}) f_{2}(t_{2}^{*})$$

$$+ \frac{t_{1}^{*} t_{1}^{*2} t_{1}^{*1} (t_{1} - \frac{1}{2})^{2}}{(1 - t_{1})(1 - t_{2})(1 - t_{1} - t_{2})} f_{1}(t_{1}^{*}) f_{2}(t_{2}^{*})$$

$$+ E[N].$$

$$(3.2.25)$$

The value of N should be determined exactly for $F_N(t_1^*)$ by searching for the value N such that $F_N(N-1) <$ and $F_N(N)$. For the case where $F_N(t_1^*) < F_N(t_2^*)$, a search for an approximate value N should be made using

$$F_{N}(t) = 1 - \frac{1}{1 - 1} f_{1}(t_{1}^{*})\overline{F}_{2}(t)$$
such that $F_N(N - 1) <$ and $F_N(N)$. For $>F_N(t_2^*)$, an approximate value of N can be obtained by solving the following system of inequalities for N :

$$F_{N}(t_{2}^{*}+N-t_{2}^{*}) = 1 - \frac{\frac{t_{2}^{*}-t_{1}^{*}+N-t_{2}^{*}+1}{2}}{(1-t_{1})(1-t_{2})} f_{1}(t_{1}^{*})f_{2}(t_{2}^{*})$$

and

$$F_{N}(t_{2}^{*}+N-1-t_{2}^{*}) = 1 - \frac{t_{2}^{*}-t_{1}^{*}+N-t_{2}^{*}}{(1-t_{1})(1-t_{2})} f_{1}(t_{1}^{*})f_{2}(t_{2}^{*}) < 0$$

The solution to this system is given by the expression on the right-hand side of the approximation (3.2.25). This is an approximate value for N .

N
$$t_{1}^{*} - 1 + \frac{\log([(1 -)(1 -)(1 -)(1 -)]/[f_{1}(t_{1}^{*})f_{2}(t_{2}^{*})])}{\log(1)}$$
. (3.2.26)

A FORTRAN program is given in Appendix I implementing the combined run length distribution approach for the combined \overline{X} - and R-chart.

3.3 Combined Markov Chain Approach

In this section, we develop the Markov chain representation of the combined Shewhart \overline{X} - and R- (or S-) charts supplemented with runs rules. Using Champ and Woodall's (1987) procedure for a Markov chain representation can be determined for each of the individual charts. The FORTRAN program given by Champ and Woodall (1990) outputs a matrix containing information about the regions of the chart and state, next-state transitions.

Let i_1 and i_2 represent non-absorbing states, respectively, of the Markov chain representation of the Shewhart \overline{X} - and R- (or S-) charts supplemented with runs rules. Further, let h_1 and h_2 represent the respective number of non-absorbing states of the

Markov chain representations. A non-absorbing state of the combined chart can be represented by the ordered pair (i_1, i_2) . Let i represent the number of this state. A convenient way of numbering these states is to let $i = (h_2 - 1) i_1 + i_2$. Since \overline{X} - and R-(or S-) are independent, the probability of making a transition from the non-absorbing state (i_1, i_2) to the non-absorbing state (j_1, j_2) is

$$\mathbf{p}_{i,j} = \mathbf{P}[\mathbf{i}_1 \ \mathbf{j}_1] \mathbf{P}[\mathbf{i}_2 \ \mathbf{j}_2].$$
(3.3.1)

We need only the matrix, \mathbf{Q} , of probabilities given in equation (3.3.1) to evaluate the run length distribution of the combined chart.

The run length, $N^{(i)}$, of the combined chart starting in the non-absorbing state i, is defined as the number of the first sampling stage in which either one or both charts signals. For convenience we define the vector of run lengths, **N**, by

$$\mathbf{N}_{\tilde{\mathbf{N}}} = \left[\mathbf{N}^{(1)}, \mathbf{N}^{(2)}, \dots, \mathbf{N}^{(h)},\right]$$

where $h = h_1h_2$. Using the results found in Brook and Evans (1972), the run length distributions is given by

$$\mathbf{P}[\mathbf{N} = \mathbf{t}] = \mathbf{Q}^{t-1} (\mathbf{I} - \mathbf{Q}) \mathbf{1}$$
(3.3.2)

t=1, 2, 3, ..., where **1** is a column vector of ones with the same column dimension as **Q** and $\mathbf{t} = [t, t, ..., t] = t\mathbf{1}$. We define the vector $\mathbf{F} = (\mathbf{t})$ by

$$\mathbf{F}(\mathbf{t}) = [\mathbf{F}^{(1)}(\mathbf{t}), \, \mathbf{F}^{(2)}(\mathbf{t}), \, \dots, \, \mathbf{F}^{(h)}(\mathbf{t})]$$
(3.3.3)

where $F^{(i)}(t)$ is the CDF of the run length, $N^{(i)}$ i=1, 2, ..., h. Using equation (3.3.2), the vector of CDFs can be calculated by

$$\mathbf{F}_{\tilde{\mathbf{L}}}\left(\mathbf{t}\right) = \left(\mathbf{I} - \mathbf{Q}^{t+1}\right)\mathbf{1},\tag{3.3.4}$$

t=1, 2, 3, \dots This expression has a similar form to the expression for the CDF of a geometric distribution.

As shown in Brook and Evans (1972), the vector of ARLs can be determined by the expression

$$\boldsymbol{\mu} = \mathbf{E}[\mathbf{N}] = (\mathbf{I} - \mathbf{Q})^{-1} \mathbf{1}.$$
(3.3.5)

Determining the ARLs of the combined chart using equation (3.3.5) may not be practical since the number of non-absorbing states may be large. The most efficient method of evaluating the ARL of interest is to use equation (3.3.2) and Woodall's (1983) method for approximating the tail probabilities with a geometric distribution. The FORTRAN program given by Champ and Woodall (1990) was modified to evaluate the ARLs, standard deviations of the run length, and percentage points of the run length for the combined charting procedure. The modified program is listed in Appendix II along with an explanation of how to run the program.

3.4 Evaluating the Run Length Distribution When No Standards Are Given

In the previous sections, methods for determining the parameters of the run length distribution assumed the in-control mean and standard deviation were known. In this case the parameters, μ_0 and $_0$, are referred to as target values or standards. In many situations no standards are given and the parameters, μ_0 and $_0$, are estimated from a preliminary set

of observations taken from the process when it is believed to be in-control. In this section, we develop a method for analyzing the run length distribution when no standards are given.

Reynolds, Ghosh and Hui (1981) investigate the run length properties of the \overline{X} -chart when the process variance is estimated from initial data. They use the standard deviation of the preliminary data as their estimate of the process variance. An expression for the ARL is given in the form of an integral equation which was evaluated numerically. In their evaluation of the ARL, it was shown how using small sample sizes to estimate the process variance increases the ARL and the variance of the run length. Also for some preliminary sample sizes the ARL will be infinite.

Ng and Case (1992) evaluated the run length properties of the \overline{X} -chart when both the in-control mean and standard deviation are estimated from preliminary data. They assume m preliminary samples each of size n are available from an in-control process. Their estimator for the in-control mean of the process is the mean of the sample means of the m preliminary samples. The mean of the ranges of these m samples was used as an estimate of the process in-control standard deviation. They expressed the ARL as an integral which they evaluated using numerical integration.

Let $\hat{\mu}_0$ and $\hat{}_0$, respectively, be estimators of μ_0 and $\hat{}_0$. Further, let the joint probability density function of $\hat{\mu}_0$ and $\hat{}_0$, be given by $f_{\hat{\mu}_0,\hat{}_0}(\mathbf{u},\mathbf{v} \mid \mu_0, {}_0)$. For the case where $\hat{\mu}_0$ and $\hat{}_0$, are independent then

$$f_{\hat{\mu}_{0,0}}(u, v \mid \mu_{0}, u_{0}) = f_{\hat{\mu}_{0}}(u \mid \mu_{0}, u_{0}) f_{\hat{\mu}_{0}}(v \mid \mu_{0}, u_{0}).$$

Consider any parameter, = $(\mu_0, {}_0, \mu, \mu)$ of the run length distribution. If μ_0 and ${}_0$ are replaced with their estimators, then $\hat{} = \hat{}(\hat{\mu}_0, \hat{}_0, \mu, \mu)$ is a random variable. Defining $\hat{} = \hat{}(\hat{\mu}_0, \hat{}_0, \mu, \mu, \mu)$ such that the transformation of $(\hat{}, \hat{})$ of $(\hat{\mu}_0, \hat{}_0)$ is one-to-one then the pdf $\hat{}$ can be determined from

$$\mathbf{f}_{\hat{\boldsymbol{\mu}}}\left(\mathbf{w} \mid \boldsymbol{\mu}_{0}, \boldsymbol{u}_{0}\right) = \mathbf{f}_{\hat{\boldsymbol{\mu}}_{0}}\left(\mathbf{u} \mid \boldsymbol{\mu}_{0}, \boldsymbol{u}_{0}\right) \mathbf{f}_{\hat{\boldsymbol{\mu}}_{0}}\left(\mathbf{v} \mid \boldsymbol{\mu}_{0}, \boldsymbol{u}_{0}\right).$$

As can be seen, any parameter of the distribution of the random variable $\hat{}$ is a parameter of the distribution of the run length.

In previous sections, the parameters, = $(\mu_0, {}_0, \mu, {})$, of interest were the average run length, standard deviation of the run length, and percentage points of the run length. When no standards are given these values are random quantities, $\hat{\mu}_N = \hat{\mu}_N(\hat{\mu}_0, \hat{}_0, \mu, {})$, $\hat{\mu}_N = \hat{\mu}_N(\hat{\mu}_0, \hat{}_0, \mu, {})$, $\hat{N} = \hat{N}(\hat{\mu}_0, \hat{}_0, \mu, {})$. Two parameters of interest of these random variables are their means and standard deviations. These parameters can be determined from

$$E[\hat{}] = wf_{\hat{}}(w \mid \mu_{0}, _{0}) dw; \qquad (3.4.1)$$

$$E[^{2}] = w^{2} f_{2}(w \mid \mu_{0}, \mu_{0}) dw. \qquad (3.4.2)$$

It now follows the average run length of the chart is given by $\mu_N = E[N] = E[\hat{\mu}_N]$ when no standards are given. Similarly, the standard deviation and percentage points of the run length distribution are, respectively, $_N = E[\hat{n}_N]$ and $N = E[\hat{N}]$. A FORTRAN program is presently under development for determining the ARL, STDRL (standard deviation of the run length), and selected percentage points of the run length distribution for various standardized shifts in μ_0 and $_0$, when no standards are given.

A commonly used procedure for determining parameters of the run length distribution is simulation. Conceptually this method is quite simple. For a given charting procedure, a large number, L, of run lengths are independently simulated from the run length distribution. This is viewed as a random sample, RL_1 , RL_2 , ..., RL_L , from the run length distribution of the chart. The \overline{RL} is used as an estimator for μ_N , the standard deviation of this sample, S_{RL} , is used as an estimator of $_N$, and functions of the order statistics, $RL_{(1)}, RL_{(2)}, ..., RL_{(L)}$, could be used as estimators of the percentage points, N .

3.5 Evaluating the $P[N=N_1]$ with $P[N=N_2]$

In this section, we give expressions for evaluating the probability the \overline{X} -chart signals on or before the R- (or S-) chart. That is, we determine $P[N=N_1]=P[N_1 N_2]$. Equivalent expressions will be given for the probability the run length of the combined chart is the run length of the R- (or S-) chart, $P[N=N_2]=P[N_2 N_1]$. With $E[N_1] =$ $E[N_2]$, it will be demonstrated it is more likely the \overline{X} -chart will signal on or before the R-(or S-) chart for a shift in the mean. Further for an increase in the standard deviation of the process, it is more likely the R- (or S-) chart will signal first.

First, consider the case where the basic Shewhart \overline{X} -chart and R- (or S-) charts are combined to monitor the mean and standard deviation. As stated previously, the run lengths, N₁ and N₂, each have geometric distributions with respective parameters

$$\mathbf{p}_1 = \mathbf{P}[\overline{\mathbf{X}} \quad \mathbf{L}\mathbf{C}\mathbf{L}_1] + \mathbf{P}[\overline{\mathbf{X}} \quad \mathbf{U}\mathbf{C}\mathbf{L}_1]$$

and

$$p_2 = P[R(or S) LCL_2] + P[R(or S) UCL_2]$$

It needs to be noted the upper and lower control limits for the \overline{X} -chart are functions of both μ_0 and $_0$, whereas, the upper and lower control limits for the R- (and S-) chart are only functions of $_0$. Further the distribution of \overline{X} is a function of μ and ; and the distribution of R (and S) is a function of only . It follows the value, $p_1 = p_1(\mu_0, _0, \mu,)$, is a function of μ and the value, $p_2 = p_2(_0,)$, is a function of .

Now consider the probability the minimum run length is equal to the length of the \overline{X} - chart. Thus,

$$P[N=N_{1}] = P[N_{1} \ N_{2}]$$

$$= \sum_{t=1}^{t} P[N_{1} = t]P[N_{2} \ t]$$

$$= \sum_{t=1}^{t} p_{1}q_{1}^{t-1}q_{2}^{t-1}$$

$$= \frac{p_{1}}{1 - q_{1}q_{2}} \sum_{t=1}^{t} p_{1}(q_{1}q_{2})^{t-1}(1 - q_{1}q_{2})$$

$$= \frac{p_{1}}{1 - (1 - p_{1})(1 - p_{2})}$$

$$= \frac{E[N_{2}]}{E[N_{1}] + E[N_{2}] - 1}.$$
(3.5.1)

It follows the probability the minimum run length is equal to the run length of the R- or (S-) chart is

$$P[N=N_{2}] = P[N_{2} N_{1}]$$

$$= \frac{p_{2}}{p_{1} + p_{2} - p_{1}p_{2}}$$

$$= \frac{E[N_{1}]}{E[N_{1}] + E[N_{2}] - 1}.$$
(3.5.2)

Also it is easy to show

$$P[N_1 < N_2] = \frac{E[N_2] - 1}{E[N_1] + E[N_2] - 1}$$
(3.5.3)

$$P[N_1 = N_2] = \frac{1}{E[N_1] + E[N_2] - 1}$$
(3.5.4)

$$P[N_1 > N_2] = \frac{E[N_1] - 1}{E[N_1] + E[N_2] - 1}.$$
(3.5.5)

It may be of interest to determine the conditions under which $P[N_1 \ N_2] > \frac{1}{2}$. For this to hold

$$\frac{E[N_2]}{E[N_1] + E[N_2] - 1} > \frac{1}{2}$$

or

$$E[N_2] > E[N_1] - 1.$$

Thus it is more likely the \overline{X} -chart signals on or before the R- (or S-) chart if the ARL of the R- (S-) chart exceeds one less than the ARL of the \overline{X} -chart. As will be illustrated in Chapter 4, this still holds approximately when runs rules are added to one or both charts.

Now, consider the combined chart where the Shewhart \overline{X} - and R- (or S-) charts are supplemented with runs rules. Assuming $t_1^* = t_2^*$, the probability \overline{X} -chart signals on or before the R- (or S-) chart and is given by

$$P[N=N_1] = P[N_1 \ N_2]$$

$$= \prod_{t=1}^{t} P[N_1 = t, N_2 \quad t]$$

$$= \prod_{t=1}^{t_1} P[N_1 = t] P[N_2 \quad t]$$

$$= \prod_{t=1}^{t_1^*} P[N_1 = t] P[N_2 \quad t] + \prod_{t=t_1^*+1}^{t_2^*} P[N_1 = t] P[N_2 \quad t]$$

+
$$\Pr[N_1 = t]P[N_2 \quad t]$$

$$= \prod_{t=1}^{t_1^*} P[N_1 = t] P[N_2 \quad t] + \prod_{t=1}^{t_2^* - t_1^*} P[N_1 = t_1^* + t] P[N_2 \quad t_1^* + t]$$

+
$$P[N_1 = t_1^* + t_2^* - t_1^* + t]P[N_2 \quad t_2^* + t]$$

$$\sum_{t=1}^{t_1^*} P[N_1 = t] P[N_2 \quad t] + \sum_{t=1}^{t_2^* - t_1^*} P[N_1 = t_1^*] P[N_2 \quad t_1^* + t]$$

+
$$\lim_{t \to 1} \sum_{1}^{t_{2}^{*} - t_{1}^{*} + t} P[N_{1} = t_{1}^{*}] \frac{t_{2}}{1 - t_{2}} P[N_{2} = t_{2}^{*}]$$

$$= \prod_{t=1}^{t_1^*} P[N_1 = t] P[N_2 \quad t] + P[N_1 = t_1^*] \prod_{t=1}^{t_2^* - t_1^*} P[N_2 \quad t_1^* + t]$$

$$+\frac{\frac{t_{2}^{*}-t_{1}^{*}}{1-2}}{1-2}P[N_{1}=t_{1}^{*}]P[N_{2}=t_{2}^{*}]_{t=1}(t_{1}-2)^{t}$$

$$= \int_{t=1}^{t_{1}^{*}} P[N_{1} = t] P[N_{2} \quad t] + P[N_{1} = t_{1}^{*}] \int_{t=1}^{t_{2}^{*} - t_{1}^{*}} P[N_{2} \quad t_{1}^{*} + t]$$

$$+ \frac{\int_{t=1}^{t_{2}^{*} - t_{1}^{*} + 1}}{(1 - 2)(1 - 1 - 2)} P[N_{1} = t_{1}^{*}] P[N_{2} = t_{2}^{*}]$$
(3.5.6)

which follows from equation (3.2.14). If we assume $t_1^* = t_2^*$, then

$$P[N=N_1] = \int_{t=1}^{t_2^*} P[N_1 = t] P[N_2 \quad t] + \int_{t=t_2^*+1}^{t_1^*} P[N_1 = t] P[N_2 \quad t]$$

 $+ \underset{t=t_1^*+1}{P[N_1 = t]P[N_2 \quad t]}$

$$= \sum_{t=1}^{t_2^*} P[N_1 = t] P[N_2 \quad t] + \sum_{t=1}^{t_1^* - t_2^*} P[N_1 = t_2^* + t] P[N_2 \quad t_2^* + t]$$

+
$$P[N_1 = t_1^* + t]P[N_2 \quad t_2^* + t_1^* - t_2^* + t]$$

$$\sum_{t=1}^{t_2^*} P[N_1 = t] P[N_2 \quad t] + \sum_{t=1}^{t_1^* - t_2^*} P[N_1 = t_2^* + t] \frac{\frac{t_2}{2} P[N_2 = t_2^*]}{1 - 2}$$

+
$$\prod_{t=1}^{t} \Pr[N_1 = t_1^*] \frac{\frac{t_1^* - t_2^* + t}{2}}{1 - 2} \Pr[N_2 = t_2^*]$$

$$= \sum_{t=1}^{t_2^*} P[N_1 = t] P[N_2 \quad t] + \frac{P[N_2 = t_2^*]}{1 - 2} \sum_{t=1}^{t_1^* - t_2^*} {}^t P[N_1 \quad t_2^* + t]$$

$$+\frac{\frac{t_1^*-t_2^*}{2}P[N_1=t_1^*]P[N_2=t_2^*]}{1-2} t_{t=1}^{t_1} (t_1, t_2)^{t_1}$$

$$= \int_{t=1}^{t_{2}^{*}} P[N_{1} = t] P[N_{2} \quad t] + \frac{P[N_{2} = t_{2}^{*}]}{1 - 2} \int_{t=1}^{t_{1}^{*} - t_{2}^{*}} P[N_{1} \quad t_{2}^{*} + t] + \frac{1}{2} \frac{t_{1}^{*} - t_{2}^{*} + 1}{(1 - 2)(1 - 1)} P[N_{2} = t_{2}^{*}]}{(1 - 2)(1 - 1)}.$$
(3.5.7)

The approximate probability the \overline{X} -chart signals on or before the R- (or S-) chart, assuming t_1^* t_2^* , is given by

$$P[N_{1} < N_{2}] = \int_{t=1}^{t_{1}^{*}} P[N_{1} = t] P[N_{2} > t] + P[N_{1} = t_{1}^{*}] \int_{t=1}^{t_{2}^{*} - t_{1}^{*}} P[N_{2} = t_{1}^{*} + t]$$

+
$$\frac{\frac{t_{2}^{*} - t_{1}^{*} + 1}{2}}{(1 - \frac{1}{2})(1 - \frac{1}{1 - 2})} P[N_{1} = t_{1}^{*}] P[N_{2} = t_{2}^{*}]$$
(3.5.8)

and assuming $t_2^* = t_1^*$,

$$P[N_{1} < N_{2}] = \int_{t=1}^{t_{2}^{*}} P[N_{1} = t] P[N_{2} > t] + \frac{P[N_{2} = t_{2}^{*}]}{1 - 2} \int_{t=1}^{t_{1}^{*} - t_{2}^{*}} P[N_{1} = t_{2}^{*} + t] + \frac{2 \int_{1-2}^{t_{1}^{*} - t_{2}^{*} + 1} P[N_{1} = t_{1}^{*}] P[N_{2} = t_{2}^{*}]}{(1 - 2)(1 - 1 - 2)}.$$
(3.5.9)

3.6 Methods for Evaluating Run Length Distributions of Other Combined Charts

Jennett and Welch (1939) proposed plotting the statistic, $(U - \overline{X})/S$, or the statistic, $(U - \overline{X})/W$, where W is an easily calculated estimator of the standard deviation such as the sample range. The value, U, is an upper tolerance limit for the quality measure, X. Although Jennett and Welch (1939) did not consider supplementing runs rules for this chart, rules could be added. Addition of runs rules to this chart is not considered in this research.

Consider the chart based on $(U - \overline{X})/S$. To determine the control limits, we need the distribution of $(U - \overline{X})/S$. To obtain the distribution of this statistic, first note $U - \overline{X}$ has a normal distribution with mean, U-µ, and variance, $^2/n$. Now consider the following

$$\frac{U-\overline{X}}{S} = \sqrt{n} \frac{\frac{U-\overline{X}}{\sqrt{n}}}{\sqrt{\frac{(n-1)S^2}{2}}/(n-1)} = \sqrt{n} \frac{\frac{(U-\overline{X})-(U-\mu)}{\sqrt{n}} + \frac{(U-\mu)}{\sqrt{n}}}{\sqrt{\frac{(n-1)S^2}{2}}/(n-1)}$$

$$(U-\mu)$$

$$= \sqrt{n} \frac{Z + \frac{(U - \mu)}{\sqrt{n}}}{\sqrt{\frac{2}{(n-1)}}} = \sqrt{n} t_{n-1}$$

where t_{n-1} denotes a random variable having a noncentral t-distribution with n-1 degrees of freedom and noncentrality parameter, $=\frac{(U-\mu)}{\sqrt{n}}$. We note here the statistic, $(U-\overline{X})/(S/\sqrt{n})$ has a noncentral t-distribution with n-1 degrees of freedom and noncentrality parameter, .

The expected value of the random variable,
$$\frac{U-X}{S}$$
, is given by
 $E[\frac{U-\overline{X}}{S}] = E[U-\overline{X}] E[S^{-1}]$ (Since \overline{X} and S are independent)
 $= (U-\mu)E[S^{-1}]$

$$= (U - \mu)E[(S^2)^{-1/2}].$$

It can be shown S² has a gamma distribution with parameters $\frac{2^{-2}}{n-1}$ and $\frac{n-1}{2}$. Thus, $E[(S^2)^{-1/2}]$ is given by

$$E[(S^{2})^{-1/2}] = v^{-1/2} - \frac{1}{2} \frac{1}{n-1} v^{\frac{n-1}{2}} e^{-v/2} dv$$

$$\frac{n-1}{2} \frac{2^{2}}{n-1} v^{\frac{n-1}{2}} v^{\frac{n-1}{2$$

$$=(c_3)^{-1}$$
, where $c_3 = \sqrt{\frac{2}{n-1}} = \frac{\frac{n-1}{2}}{\frac{n-2}{2}}$.

Hence,

$$E[\frac{U-\overline{X}}{S}] = c_3^{-1} \frac{U-\mu}{S}.$$

The variance of (U - \overline{X})/S is given by

$$V[\frac{U-\overline{X}}{S}] = \frac{n-1}{n-3} - \frac{1}{c_3} - \frac{U-\mu}{2} + \frac{n-1}{n(n-3)}$$

Define $_0 = \frac{U - \mu_0}{0}$, where μ_0 and $_0$ are, respectively, the in-control values of

 μ and μ . The control limits for this charting procedure can now be expressed as

LCL =
$$\sqrt{n} t_{n-1, 0, L}$$

CL =
$$c_{3}^{-1} _{0}$$

UCL = $\sqrt{n} t_{n-1, 0, 1- 0}$

where $t_{n-1,0}$ is the th percentage point of a noncentral t-distribution with n - 1 degrees of freedom and noncentrality parameter, ₀. The probability this chart signals at any sampling stage is

$$p = 1 - F_{t_{n-1,}}\left(t_{n-1,0,1-U}\right) + F_{t_{n-1,0}}\left(t_{n-1,0,1-U}\right).$$
(3.6.1)

Thus,

$$\mu_{\rm N} = \frac{1}{\rm p}; \quad_{\rm N} = \frac{\sqrt{1-\rm p}}{\rm p}; \text{and } {\rm N} = \frac{\log(1-)}{\log(1-\rm p)},$$

where N denotes the run length of this charting procedure.

When changes in the standard deviation are relatively rare or unimportant, Page (1955) proposed a supplementing the \overline{X} -chart with certain runs rules. These runs rules were listed in Chapter 2. Using a difference equation approach, he obtained the following expression for the ARL of this charting procedure

$$ARL = \frac{(1 - rs - r^{m} - s^{m} + sr^{m} + s^{m}r)}{p_{2} + rs(1 + p_{0}) + p_{0}(r^{m} + s^{m} - sr^{m} - s^{m}r)}$$
(3.6.2)

where r (s) is the probability a sample point falls between the upper (lower) warning and action lines, p_0 the probability a sample point falls between the warning limits, and p_2 the probability a sample point falls outside the action limits.

The combined \overline{X} - and S^2 - chart investigated by Chengular, Arnold, and Reynolds (1989) can be analyzed in similar manner as the combined \overline{X} - and S-chart. Their procedure, based on the statistic $\int_{j=1}^{n} (X_{t,j} - \mu_0)^2 / \int_{0}^{2}$, has a probability, p, of signaling at

any sampling stage given by

$$\mathbf{p} = \mathbf{F} \begin{pmatrix} 2 \\ n, 1 - 1 \end{pmatrix} - \mathbf{F} \begin{pmatrix} 2 \\ n, 1 \end{pmatrix}$$
(3.6.3)

where F() is the CDF of a noncentral chi square distribution with n degrees of freedom and noncentrality parameter, $\left[(\mu - \mu_0)/(_0/\sqrt{n})\right]^2$.

The simultaneous control chart proposed by White and Schroeder (1982) plotted on separate charts the median (\tilde{X}) and inner quartile range (IQR). The probability of a signal at any sampling stage is

$$p = 1 - P \Big[\tilde{X}_{n, 1-1} < \tilde{X} < \tilde{X}_{n,1-1}, IQR_{n, 2-2} < IQR < IQR_{n,1-2} \Big]$$

= 1 - $\int_{LCL_{1} LCL_{2}}^{UCL_{1} UCL_{2}} f_{X,IQR}(u, v|\mu,) dv du.$ (3.6.4)

The combined control chart based on the statistics $T = (\overline{X} - \mu_0)/(S/\sqrt{n})$ and S, we proposed in Chapter 2 has probability, p, of giving a signal at any sampling stage of

$$p = 1 - P\left[-t_{n-1,1-1} < T < t_{n-1,1-1}, n-1, 2-2 < S < n-1,1-2\right]$$

$$= 1 - \int_{-t_{n-1,1-1}}^{t_{n-1,1-1}} f_{T,S}(u,v|\mu,) dv du, \qquad (3.6.5)$$

where t_{n-1} , and $_{n-1}$, are the th percentage points, respectively, of the t- and - distributions each with n-1 degrees of freedom. It can be shown the joint distribution is

$$f_{T,S}(u,v|\mu,) = \frac{1}{\sqrt{2}} \left(\frac{1}{\sqrt{v}}\right) e^{-\frac{1}{2} \frac{u - [\mu - \mu_0] \sqrt{v} \sqrt{n}}{v}^2}$$
$$\times \frac{2}{\frac{n-1}{2}} \frac{2^{-\frac{n}{2}}}{n-1} v^{n-2} e^{-v^2 \sqrt{\frac{2}{n-1}}}$$

for - $\langle u \rangle$ and v 0; and zero, otherwise.

If runs rules are added the T- or S- chart the transition probabilities are computed by

$$p_{i,j} = P[i_1 \quad j_1, i_2 \quad j_2]$$

= $P[a_1 < T < b_1, a_1 < S < b_1]$
= $\sum_{a_1 a_2}^{b_1 b_2} f_{T,S}(u, v | \mu,) dv du$ (3.6.7)

where $f_{T,S}(u,v|\mu, \)$ is given in equation (3.6.6).

The purpose of this section is to give brief outlines of ways to evaluate the run length properties of various simultaneous control charting procedures. Although, no further work will be done in this research with these procedures, more work needs to be done to give a full comparison of all available simultaneous control charting procedures.

(3.6.6)

Chapter 4. SELECTING A COMBINED CHARTING PROCEDURE

4.1 Introduction

In this chapter, we discuss the design of combined \overline{X} - and R- (or S-) control charts supplemented with runs rules. The criteria used for selecting a chart is based on what will be referred to as the ARL criteria. This criteria chooses the best chart from a set of charts with the same in-control ARL as the one with the smallest out-of-control ARL for a given shift in the parameters. In the case that more than one of these charts exist, a non-statistical user defined simplicity of use criteria should then be used to determine the best chart. Another desirable characteristic of a combined charting procedure is to have a signal on the \overline{X} -chart more likely if the mean shifts and a signal on the R- (or S-) more likely if the standard deviation shifts.

4.2 Effects of Shifts in the Standard Deviation

It appears for various combined charting procedures equation (3.2.8) gives a good approximation to E[N] when the process is in-control. This is illustrated in the examples to follow. Thus, equation (3.2.8) provides a simple formula for determining the ARL of the combined chart when the ARLs of the \overline{X} - and R- (or S-) charts are given. More generally, if two of the three ARLs are given in equation (3.2.8) the other can be determined (at least approximately).

Consider the \overline{X} - and R-charts defined, respectively, by the sets of runs rules

$$C_{(1)} = \{T(1,1,-,-3), T(2,3,-3,-2), T(2,3,2,3), T(1,1,3,)\}$$

and

$$C_{(2)} = \{T(1,1,-,-2.233), T(4,5,-2.233,-1.005), T(4,5,1.004,3.537), T(1,1,3.537,)\}.$$

The chart, $C_{(2)}$, was recommended in Lowry, Champ, and Woodall (1994) for samples of size 5. Table 4.2.1 lists the ARLs for the charts, $C_{(1)}$, $C_{(2)}$, and the combined chart $C_{(1,2)}$. The columns are labeled respectively, $ARL_{(1)}$, $ARL_{(2)}$, and $ARL_{(1,2)}$. Further, Table 4.2.1 contains a column headed $A\tilde{R}L_{(1,2)}$ giving an approximation to the ARL of the combined chart using equation (3.2.8). As can be seen, equation (3.2.8) does provide in general a good approximation.

As can be seen in Table 4.2.1, a change in either the mean or standard deviation has an impact on the average run length of the combined chart. This supports the usual recommendation to examine the R-chart first before the \overline{X} -chart in an attempt to determine the reason for a signal.

We recommend first selecting the in-control ARL of the combined charting procedure. The ARLs of the \overline{X} - and R- (or S-) charts supplemented with runs rules can then be selected to satisfy equation (3.2.8). These charts can then be designed separately at this point. A run length analysis of the combined charting procedure should be done so the practitioner knows what to expect, on the average, as to the run length performance of the combined chart.

For this particular example, the probability of the \overline{X} -chart signaling on or before the R-chart for no change in the standard deviation is generally less than one-half for shifts in the mean of up to about a 20% increase. For shifts in the mean of 30% or more of an increase with no shift in the standard deviation, the \overline{X} -chart is more likely to signal on or before the R-chart. In this example, the ARL of the \overline{X} -chart is significantly larger than the ARL of the R- chart. In the next example, both the \overline{X} - chart and the R-chart have the same in-control mean.

TABLE 4.2.1 Various shifts in and .						
		ARL ₍₁₎	ARL ₍₂₎	ARL _(1,2)	$\tilde{ARL}_{(1,2)}$	$\mathbf{P}[\mathbf{N} = \mathbf{N}_1]$
0.00	1.00	225.44	166.41	96.58	95.98	0.42696
0.00	1.10	99.88	75.88	43.92	43.37	0.43690
0.00	1.20	53.65	32.26	20.87	20.38	0.38369
0.00	1.30	33.01	16.88	11.81	11.40	0.34932
0.00	1.40	22.41	10.49	7.71	7.37	0.33273
0.10	1.00	211.45	166.41	93.97	93.37	0.44289
0.10	1.10	95.67	75.88	43.13	42.57	0.44779
0.10	1.20	52.08	32.26	20.65	20.16	0.39109
0.10	1.30	32.32	16.88	11.73	11.32	0.35450
0.10	1.40	22.07	10.49	7.68	7.34	0.33652
0.20	1.00	177.56	166.41	86.76	86.15	0.48693
0.20	1.10	84.82	75.88	40.87	40.30	0.47859
0.20	1.20	47.84	32.26	20.02	19.51	0.41250
0.20	1.30	30.40	16.88	11.51	11.09	0.36968
0.20	1.40	21.09	10.49	7.59	7.24	0.34769
0.30	1.00	138.68	166.41	76.51	75.89	0.54963
0.30	1.10	71.05	75.88	37.52	36.94	0.52440
0.30	1.20	42.07	32.26	19.03	18.51	0.44579
0.30	1.30	27.66	16.88	11.16	10.72	0.39387
0.30	1.40	19.65	10.49	7.43	7.07	0.36574
0.40	1.00	104.46	166.41	65.00	64.41	0.61993
0.40	1.10	57.50	75.88	33.53	32.96	0.57891
0.40	1.20	35.90	32.26	17.77	17.24	0.48791
0.40	1.30	24.53	16.88	10.69	10.25	0.42558
0.40	1.40	17.93	10.49	7.23	6.86	0.38987

Consider a combined \overline{X} - and R chart supplemented with the following runs rules:

$$\overline{X} \text{-chart:} \qquad C_{(1)} = \{ T(1,1,-,-3), T(2,3,-3,-2), T(2,3,2,3), T(1,1,3,) \}$$
R-chart:
$$C_{(2)} = \{ T(1,1,-,-2.233), T(4,5,-2.2330,-1.1105), \\ T(4,5,1.114,3.537), T(1,1,3.537,) \}.$$

Again let $C_{(1,2)}$ denote the combined chart. As can be seen from Table 4.2.2, the ARLs of these charts are approximately the same.

TABLE 4.2.2 Various shifts in and .						
		$ARL_{(1)} ARL_{(2)} ARL_{(1,2)} A\tilde{R}L_{(1,2)} P$		$P[N = N_1]$		
0.00	1.00	225.44	225.17	113.38	112.90	0.50170
0.00	1.10	99.88	94.46	49.28	48.80	0.49084
0.00	1.20	53.65	38.04	22.96	22.50	0.42296
0.00	1.30	33.01	19.05	12.71	12.32	0.37701
0.00	1.40	22.41	11.45	8.14	7.81	0.35209
0.10	1.00	211.45	225.17	109.78	109.30	0.51787
0.10	1.10	95.67	94.46	48.27	47.78	0.50185
0.10	1.20	52.08	38.04	22.69	22.23	0.43055
0.10	1.30	32.32	19.05	12.62	12.22	0.38234
0.10	1.40	22.07	11.45	8.10	7.77	0.35596
0.20	1.00	177.56	225.17	100.00	99.52	0.56174
0.20	1.10	84.82	94.46	45.43	44.94	0.53268
0.20	1.20	47.84	38.04	21.91	21.44	0.45244
0.20	1.30	30.40	19.05	12.36	11.95	0.39791
0.20	1.40	21.09	11.45	7.99	7.66	0.36736
0.30	1.00	138.68	225.17	86.53	86.06	0.62221
0.30	1.10	71.05	94.46	41.28	40.79	0.57776
0.30	1.20	42.07	38.04	20.70	20.23	0.48614
0.30	1.30	27.66	19.05	11.94	11.53	0.42260
0.30	1.40	19.65	11.45	7.82	7.48	0.38574
0.40	1.00	104.46	225.17	72.00	71.57	0.68737
0.40	1.10	57.50	94.46	36.45	35.98	0.63022
0.40	1.20	35.90	38.04	19.20	18.72	0.52823
0.40	1.30	24.53	19.05	11.40	10.97	0.45472
0.40	1.40	17.93	11.45	7.59	7.23	0.41020

For this example, the probability of the \overline{X} -chart signaling on or before the R-chart for no change in the standard deviation is one-half or greater. When a shift of 30% to 40% increase in the standard deviation occurs the R-chart is more likely to signal even if shifts of 40% increase occur in the mean. It is very noticeable that the ARL for both charts goes down noticeably for shifts of this magnitude.

4.3 Selection of Control Limits for the R- and S-Charts

Lowry and Champ (1994) consider the problem of selecting the warning and action limits of the R- and S-charts. For each of these charts suggested in the literature, they found there is an interval of values for in which the ARL of these charts is greater than the in-control ARL. Presently they are working on recommendations for selecting the warning and action limits for R- and S- charts supplemented with runs rules such that the ARL of the chart is a maximum when the process is in-control. They refer to such a chart as an unbiased charting procedure. They have obtained results for the basic S-chart.

Table 4.3.1 is a reproduction of the results found in their paper. The use of Table 4.3.1 can be illustrated using the example given in Champ and Lowry (1994). Suppose the in-control value of the standard deviation is $_0 = 2$ and an S-chart based on a sample of size n = 5 with an in-control ARL = 250 is to be used. From Table 4.3.1, we obtain the values for the lower and upper control limits, $b_L = 2.157$ and $b_U = 3.659$. Now using the method described in Chapter 2 and the value of $c_4 = 0.94$, the lower and upper control limits and center line for this unbiased chart are

LCL =
$$(0.94 - 2.157\sqrt{1 - (0.94)^2}) \cdot (2) = 0.4082$$

CL = $(0.94) \cdot (2) = 1.8800$
UCL = $(0.94 + 3.659\sqrt{1 - (0.94)^2}) \cdot (2) = 4.3767$.

As indicated in their paper, Champ and Lowry (1994) are working on a similar table to Table 4.3.1 for the R-chart. Also, they are working on a method for designing unbiased R- and S-charts supplemented with runs rules. If the R- (or S-) chart is designed to be an unbiased chart, then the combined \overline{X} - and R- (or S-) chart will be unbiased.

TA	BLE 4.3	.1:Values	s of k _L an	nd k _u				
				•	ARL			
		50	100	125	200	250	500	1000
3	b _L	1.630	1.722	1.732	1.770	1.785	1.822	1.848
	$b_{\rm U}$	3.305	3.651	3.756	3.972	4.071	4.367	4.647
4	b _L	2.002	2.096	2.122	2.167	2.186	2.235	2.271
ĺ	b _U	2.400	2.716	2.814	3.014	3.107	3.385	3.651
5	b _L	1.856	2.002	2.043	2.123	2.157	2.253	2.332
İ	b _U	2.951	3.269	3.367	3.567	3.659	3.933	4.194
6	b ₁	2.120	2.266	2.308	2.389	2.425	2.524	2.608
İ	b _U	2.403	2.703	2.795	2.984	3.071	3.332	3.581
7	b ₁	1.946	2.118	2.168	2.266	2.309	2.433	2.542
ĺ	b _U	2.812	3.118	3.212	3.404	3.492	3.757	4.008
8	b ₁	2.167	2.336	2.386	2.484	2.527	2.651	2.761
	b _U	2.399	2.692	2.782	2.966	3.051	3.305	3.547
9	b ₁	1.997	2.183	2.237	2.346	2.394	2.534	2.659
	b _U	2.736	3.034	3.125	3.312	3.399	3.657	3.902
10	b ₁	2.193	2.376	2.430	2.537	2.585	2.724	2.848
	b _U	2.394	2.683	2.772	2.953	3.036	3.287	3.524

4.4 Concluding Remarks

This chapter contains a discussion of the design of combined \overline{X} - and R- (or S-) control charts supplemented with runs rules. The ARL criteria is used to select charts. It is important for the combined charting procedure to have a signal on the \overline{X} -chart more likely if the mean shifts and a signal on the R- (or S-) more likely if the standard deviation shifts. For shifts in the standard deviation it has been shown that equation (3.2.8) provides a simple formula for determining the ARL of the combined chart when the ARLs of the \overline{X} - and R- (or S-) charts are given. Listed in Table 4.2.1 are various shifts in the mean and standard deviation. The ARLs of the individual and combined charts as well as an

approximated ARL for the combined chart (using equation 3.2.8) and the probability of the \overline{X} -chart signaling on or before the R-chart are listed. When setting up a combined control charting procedure, it is recommended to first select the in-control ARL of the combined charting procedure. \overline{X} - and R- (or S-) charts should be designed to have equal in-control ARL's such that the combined chart has the desired ARL.

Chapter 5. CONCLUSION

5.1 General Conclusions

We have investigated the use of individual Shewhart control charts with supplementary runs rules to jointly monitor both the mean and standard deviation of a quality measure. Chapter 2, gave a general explanation of the Shewhart \overline{X} - and R- (or S-) quality control charts supplemented with runs rules. Procedures were given for setting up these individual charts to be taken as a joint control charting procedure. Other combined mean and variability charts were discussed as well. In Chapter 3, the Markov chain approach of Champ and Woodall (1987) was used to develop two methods for analyzing the run length distribution of the combined \overline{X} - and R- (or S-) charts supplemented with runs rules. These two methods provide a simple way to obtain run length properties of the combined chart when monitoring the mean and standard deviation of a normal distribution. The problem of setting up a \overline{X} - and R- (or S-) chart when no standards are given was discussed in Section 3.4. Methods were suggested for evaluating run length distributions of other combined charts. Recommendations for selecting a combined charting procedure were given in Chapter 4.

5.2 Areas of Further Research

This research has provided an analysis of what is commonly done in practice and provides a foundation for further comparison of simultaneous control charting procedures. Many other charting procedures are available and are being studied. Further study could include implementing an analytical and a simulation analysis of a charting procedure when no standards are given. A FORTRAN program is presently under development for determining the ARL, STDRL, and selected percentage points of the run length distribution when μ_0 and $_0$, are estimated from preliminary data.

In the discussion of evaluating run length distributions of other combined charts Jennett and Welch (1939) proposed plotting an estimator of the standard deviation such as the sample range. Although supplementary runs rules for this chart were not considered, rules could be added which would need further analysis.

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Appendix I PROGRAMS FOR COMBINED RUN LENGTH DISTRIBUTION APPROACH

Diagram of Programs for the Combined Run Length Distribution Approach



RULES

Description

Rules is an external data file that defines the charts. For the combined run length distribution approach a user would save two sets of runs rules defining two charts. As an example consider the following set of runs rules for the \overline{X} - and R-chart

$$\overline{\mathbf{X}}:=\{\mathbf{T}(1,1,-9,-3), \mathbf{T}(2,3,-3,-2), \mathbf{T}(2,3,2,3), \mathbf{T}(1,1,3,9)\}$$

R: ={T(1,1,-9,-2.233),T(4,5,,-2.233,,-1.005),T(4,5,1.004,3.537),

T(1,1,3.537,9)}. (Note: 9 is used as a practical value for infinity.)

Program Description: PGM1A.FOR

This program finds the Markov chain representations for the combined run length distributions approach. The rules defining the chart are read in from an external file called "RULES". Routines find the regions of the chart, the length of the state vector and the pointers to the end of the sub vector associated with each runs rule. The value of the present indicator variable is determined by runs rule and region combinations. The program then finds the state to state transitions by regions and sorts the states in ascending order of their base two representations. Any duplicate states are removed. Then the next-state transitions are numbered. Finally, the program outputs the state, next-state transition matrix.

Program Listing

C*************************************
C* PROGRAM FINDS THE MARKOV CHAIN REPRESENTATIONS *
C* OF EACH OF THE SHEWHART CHARTS, ONE TO MONITOR *
C* THE MEAN AND THE OTHER TO MONITOR THE STANDARD *
C* DEVIATION. *
C*************************************
C*
CHARACTER*80 FMT
INTEGER H,I,J,L,NS,NR,MR,CC,CK,CX,QH,SG,NT,
& NV,TMP,QQNS,K(20),M(20),D(20),PS(58),NX(58),
& X(20,10),Q(400,10),QQ(400),S(20)
REAL A(20),B(20),R(41),TP
C*
C*
C*
C*************************************
C* THIS ROUTINE INPUTS THE RULES DEFINING THE CHART. *
C*************************************
C*
OPEN (60,FILE='PGM1.OUT',STATUS='OLD')
OPEN (50,FILE='RULES',STATUS='OLD')

```
DO 999 CC=1,2
  READ(50.50) FMT
 50 FORMAT(A80)
  READ(50,FMT) NT
  DO 101 I=1,NT
   READ(50,FMT) K(I),M(I),A(I),B(I)
101 CONTINUE
C*
C* THIS ROUTINE FINDS THE REGIONS OF THE CHART.
                                                 *
C*
  R(1) = -9
  DO 201 I=1,NT
   R(2*I) = A(I)
   R(2*I+1) = B(I)
201 CONTINUE
  R(2*NT+2) = +9
  MR = 2*NT+1
  NR = MR
202 \text{ CK} = 0
  DO 204 J=1.MR
   IF (R(J).EQ.R(J+1).AND.J.LE.NR) THEN
   DO 203 L=J,NR
    R(L) = R(L+1)
203
    CONTINUE
   NR = NR-1
   CK = 1
   ENDIF
   IF (R(J).GT.R(J+1)) THEN
   TP = R(J)
   R(J) = R(J+1)
   R(J+1) = TP
   CK = 1
   ENDIF
204 CONTINUE
  MR = MR-1
  IF (MR.GT.NR) MR=NR
  IF (CK.EQ.1.AND.MR.GE.1) GOTO 202
C*
C* THIS ROUTINE FINDS THE LENGTH OF THE STATE VECTOR
                                                 *
                                                 *
C* AND THE POINTERS TO THE END OF THE SUBVECTOR
C* ASSOCIATED WITH EACH RUNS RULE.
                                                 *
C^*
  CK = 0
  NV = 0
  DO 301 I=1,NT
   NV = NV + M(I) - 1
   IF (K(I).LT.M(I)) CK = 1
301 CONTINUE
```

```
IF (CK.EQ.0) NV = NV+1
  D(1) = M(1)-1
  DO 302 I=2,NT
   D(I) = D(I-1)+M(I)-1
   IF(M(I).EQ.1)D(I) = 0
302 CONTINUE
C*
C*
C^*
C*
C* THIS ROUTINE DETERMINES THE VALUE OF THE PRESENT
                                                 *
                                                 *
C* INDICATOR VARIABLE BY RUNS RULE AND REGION
                                                 *
C* COMBINATION.
C*
  DO 402 I=1.NT
   DO 401 J=1,NR
   X(I,J) = 0
   IF (A(I).LE.R(J).AND.R(J+1).LE.B(I))
  &
     X(I,J) = 1
401 CONTINUE
402 CONTINUE
C*
C* THIS ROUTINE DETERMINES THE STATE TO STATE
                                                 *
C* TRANSITIONS BY REGIONS.
                                                 *
C*
  QQ(1) = 0
  QQNS = 2**NV-1
  NS = 1
  H = 1
500 \text{ QH} = \text{QQ(H)}
  DO 501 L=1.NV
   PS(L) = QH-2*(QH/2)
   OH = OH/2
501 CONTINUE
  DO 503 I=1.NT
   S(I) = 0
   IF (M(I).GT.1) THEN
   DO 502 L=D(I)-M(I)+2,D(I)
    S(I) = S(I) + PS(L)
502
   CONTINUE
   ENDIF
503 CONTINUE
  DO 509 J=1,NR
   SG = 0
   DO 506 I=1,NT
   IF (SG.EQ.0) THEN
    IF (S(I)+X(I,J).GE.K(I)) THEN
     SG = 1
```

ELSE IF (M(I).GT.1) NX(D(I)-M(I)+2)=X(I,J) IF (M(I).GT.2) THEN DO 504 L=D(I)-M(I)+3,D(I) NX(L) = PS(L-1)504 CONTINUE **ENDIF** ENDIF IF (X(I,J).EQ.0.AND.M(I).GT.1) THEN TMP = S(I)-PS(D(I))+1L = D(I)CK = 0505 IF (NX(L).EQ.1) THEN CK = 1IF (TMP.LT.K(I)) THEN NX(L) = 0TMP = TMP-1CK = 0ENDIF ENDIF L = L - 1TMP = TMP+1IF (CK.EQ.0.AND.L.GE.D(I)-M(I)+2) & **GOTO 505 ENDIF ENDIF** 506 CONTINUE IF (SG.EQ.0) THEN QH = NX(1)DO 507 L=2,NV QH = QH + NX(L)*(2**(L-1))507 CONTINUE CK = 0DO 508 L=1,NS IF (CK.EQ.0.AND.QH.EQ.QQ(L)) THEN Q(H,J) = QQ(L)CK = 1ENDIF 508 CONTINUE IF (CK.EQ.0) THEN NS = NS+1QQ(NS) = QHQ(H,J) = QH**ENDIF** ELSE Q(H,J) = QQNSENDIF **509 CONTINUE** H = H+1IF (H.LE.NS) GOTO 500 NS = NS+1QQ(NS) = QQNS

```
DO 510 J=1,NR
   Q(NS,J) = QONS
510 CONTINUE
C*
*
C* THIS ROUTINE SORTS THE STATES IN ASCENDING ORDER
                                                   *
C* OF THEIR BASE TWO REPRESENTATIONS.
C^*
600 \text{ H} = 0
  CK = 0
  DO 602 I=2,NS-H
   IF (QQ(I-1).GT.QQ(I)) THEN
    CK = 1
   TMP = QQ(I-1)
    QQ(I-1) = QQ(I)
    QQ(I) = TMP
    DO 601 J=1,NR
    TMP = Q(I-1,J)
     Q(I-1,J) = Q(I,J)
    Q(I,J) = TMP
    CONTINUE
601
   ENDIF
602 CONTINUE
  H = H+1
  IF (CK.EQ.1) GOTO 600
C*
C* THIS ROUTINE REMOVES ANY DUPLICATE STATES.
                                                   *
C^*
700 \text{ CK} = 0
  I = 1
701 \text{ H} = \text{I} + 1
702 \text{ CX} = 0
  DO 703 J=1,NR
   IF (Q(I,J).NE.Q(H,J)) CX=1
703 CONTINUE
  IF (CX.EQ.0) THEN
   TMP = QQ(H)
   DO 705 L=1,H-1
    DO 704 J=1,NR
    IF (Q(L,J).EQ.TMP) Q(L,J)=QQ(I)
704
    CONTINUE
705 CONTINUE
   DO 707 L=H,NS-1
   QQ(L) = QQ(L+1)
    DO 706 J=1,NR
     Q(L,J) = Q(L+1,J)
    IF (Q(L,J).EQ.TMP) Q(L,J)=QQ(I)
706
    CONTINUE
707 CONTINUE
```

```
NS = NS-1
  CK = 1
  ENDIF
  H = H + 1
  IF (H.LT.NS) GOTO 702
  I = I + 1
  IF (I.LT.NS-1) GOTO 701
  IF (CK.EQ.1) GOTO 700
C*
*
C* THIS ROUTINE NUMBERS THE NEXT-STATE TRANSITIONS.
C^*
  DO 803 I=1,NS
  DO 802 J=1,NR
   IF (Q(I,J).LT.QONS) THEN
    CK = 0
    L = 1
801
     IF (Q(I,J).EQ.QQ(L)) THEN
     Q(I,J) = L
     CK = 1
    ENDIF
    L = L + 1
    IF (CK.EQ.0.AND.L.LT.NS) GOTO 801
   ELSE
    Q(I,J) = NS
   ENDIF
802 CONTINUE
803 CONTINUE
C*
C* THIS ROUTINE OUTPUTS THE STATE, NEXT-STATE
                                               *
C* TRANSITION MATRIX.
                                               *
C^*
900 WRITE(60,961) NS,NR
961 FORMAT(2(I4,1X))
  WRITE(60,962) (R(J),J=1,NR+1)
962 FORMAT(10(F9.5))
  DO 964 I=1.NS
   WRITE(60,963) I,QQ(I),(Q(I,J),J=1,NR)
963 FORMAT(20(1X,I4))
964 CONTINUE
999 CONTINUE
  CLOSE (50)
  CLOSE (60)
C*
  STOP
  END
```

65
PGM1.OUT.

The program PGM1A.FOR writes information to this external output file. It contains the state, next-state transition matrix for the combined run length distribution procedure.

Program Description: PGM2A.FOR

This program reads combined Markov chain representation from PGM1.OUT and calculates the average run lengths and standard deviations for various positive standardized shifts in the mean for the individual chart as well as the combined charts. The program also computes the probability the \overline{X} -chart is more likely to signal on or before the R-chart, i.e. $P[N = N_1]$. There are routines that input information about the chart. The program evaluates the run length distribution of the combined \overline{X} - and R-chart, where the statistics plotted are; $\frac{\overline{X} - \mu_0}{_0/\sqrt{n}}$ and r/d2* $_0$. Algorithm AS 126 Applied Statistics (1978) Vol. 27,

No. 2 computes the probability of the normal range given T, the upper limit of integration, and N, the sample size. Algorithm AS 5 Applied Statistics (1968) Vol. 17, p.193 computes the lower tail area of non-central t-distribution. Algorithm ACM 291, Comm. ACM. (1966) Vol.9, p.684 evaluates the natural logarithm of (x). For x greater than zero this double precision function routine evaluates $\sqrt{2} * ((m * (n - 1) + 1)/2)$, c4, $\sqrt{m^*(n - 1)} * (m^*(n - 1)/2)$ which computes the cumulative distribution function P[y x] of a random variable Y having a Chi Squared distribution with n degrees of freedom using the function **dnml**. Largex is the largest value of x such that dexp(-x/2) is accurate for your particular machine.

Program Listing

```
C* COMBINED MEAN AND VARIABLITY CHARTS
                                                    *
C^*
C* PROGRAM EVALUATES THE RUN LENGTH DISTRIBUTION OF
                                                    *
C* THE COMBINED XBAR AND R CHART
                                                    *
                                                    *
C*
C* THE STATISTICS PLOTTED ARE (XBAR-MU0)/(SIGMA0/SQRT(N))
                                                    *
C* AND R/(D2*SIGMA0)
C*********
C*
C* PROGRAM 2 (PGM 2)
                                                    *
C* THIS PROGRAM CALCULATES THE AVERAGE RUN LENGTH
                                                    *
                                                    *
C* (ARL), THE STANDARD DEVIATION (STD), AND SELECTED
C* PERCENTAGE POINTS OF THE RUN LENGTH DISTRIBUTION.
                                                    *
C*
  INTEGER CC,CCC,CK(2),CV(31,9),I,II,
  & IST,J,K,L1,L2,M,MAXN,MINN,NCP,ND(2),NS(2),
  & NR(2),Q(2,200,10),QQ(2,200),SGN,STEP
  DOUBLE PRECISION ARL, ARL1, ARL2, CDF(2,101),
  & CIV,CP(9),CUM(2),DCHISQ,DL,DNML,D2(25),
  & D3(25),FCDF,L(2,200),LH,LP(2),P(2,10),
  & PDF(2,101), PRNCST, P1EQ2, P1LE2, P1LT2,
  & R(2,10), RNGPI, STD, U(2,200), ZA, ZB
C^*
  WRITE(*,*) 'INPUT COMBINED CHART BY'
  WRITE(*,*) ' '
  WRITE(*,*) '(1) XBAR AND R'
  WRITE(*,*) '(2) XBAR AND S'
  WRITE(*,*) '(3) T AND S'
  READ(*.*) CCC
  WRITE(*,*) ' '
C*
  WRITE(*,*) 'INPUT SHIFTS IN MEAN CHART'
  READ(*,*) ND(1)
C*
  WRITE(*,*) 'INPUT SHIFTS IN DISPERSION CHART'
  READ(*,*) ND(2)
C*
  WRITE(*,*) 'INPUT DIRECTION OF SHIFT'.
  &
        IN DISPERSION CHART'
  WRITE(*.*) '(1) DECREASE'
  WRITE(*,*) '(2) INCREASE'
  READ(*,*) SGN
  SGN=2*SGN-3
C*
  WRITE(*,*) 'INPUT SAMPLE SIZE'
  READ(*,*) M
```

IDF=M-1 C4=CIV(1,M)C* WRITE(*,*) 'INPUT MINIMUM N.' READ(*,*) MINN WRITE(*,*) 'INPUT MAXIMUM N.' READ(*,*) MAXN **C*** STEP=1 NCP=9 CP(1)=0.01CP(2)=0.05CP(3)=0.10CP(4) = 0.25CP(5)=0.50 CP(6)=0.75 CP(7)=0.90CP(8)=0.95 CP(9)=0.99 **C*** D2(2)=1.1283791671D0 D2(3)=1.6925687506D0 D2(4)=2.0587507460D0 D2(5)=2.3259289473D0 D2(6)=2.5344127212D0 D2(7)=2.7043567512D0 D2(8)=2.8472006121D0 D2(9)=2.9700263244D0 D2(10)=3.0775054617D0 D2(11)=3.1728727038D0 D2(12)=3.2584552798D0 D2(13)=3.3359803541D0 D2(14)=3.4067631082D0D2(15)=3.4718268899D0 D2(16) = 3.5319827861D0D2(17)=3.5878839618D0 D2(18)=3.6400637579D0 D2(19)=3.6889630232D0 D2(20)=3.7349501196D0 D2(21)=3.7783358298D0 D2(22)=3.8193846434D0 D2(23)=3.8583234233D0

 C^*

D3(2)=0.7267604553D0 D3(3)=0.7891977107D0 D3(4)=0.7740624738D0 D3(5)=0.7466376009D0 D3(6)=0.7191713092D0 D3(7)=0.6942311313D0 D3(8)=0.6721236717D0

D2(24)=3.8953481485D0 D2(25)=3.9306292195D0

```
D3(9)=0.6525962151D0
  D3(10)=0.6352897762D0
  D3(11)=0.6198643117D0
  D3(12)=0.6060285277D0
  D3(13)=0.5935411244D0
  D3(14)=0.5822042445D0
  D3(15)=0.5718557265D0
  D3(16)=0.5623621426D0
  D3(17)=0.5536130572D0
  D3(18)=0.5455164487D0
  D3(19)=0.5379951043D0
  D3(20)=0.5309837904D0
  D3(21)=0.5244270274D0
  D3(22)=0.5182773314D0
  D3(23)=0.5124938181D0
  D3(24)=0.5070410861D0
  D3(25)=0.5018883188D0
C^*
  DO 1 I=2,25
   D3(I) = DSQRT(D3(I))
  CONTINUE
1
C*
C* THIS ROUTINE INPUTS INFORMATION ABOUT THE CHART.
                                                    *
C*
  OPEN (50, FILE='PGM1.OUT', STATUS='OLD')
  DO 55 CC=1.2
  READ(50,51) NS(CC),NR(CC)
 51 FORMAT(2(I4,1X))
  READ(50,52) (R(CC,J),J=1,NR(CC)+1)
 52 FORMAT(10(F9.5))
  DO 54 I=1.NS(CC)
    READ(50,53) II,IST,(Q(CC,I,J),J=1,NR(CC))
 53
    FORMAT(20(1X,I4))
 54 CONTINUE
 55 CONTINUE
  CLOSE (50)
C*
C* THIS ROUTINE CALCULATES THE AVERAGE RUN LENGTHS
                                                    *
C* AND STANDARD DEVIATIONS OF THE CHART FOR VARIOUS
                                                    *
                                                    *
C* POSITIVE STANDARDIZED SHIFTS IN THE MEAN.
C^*
C^*
  OPEN(60,FILE='PGM2.OUT',STATUS='OLD')
  DO 113 L1=0,ND(1),STEP
  DO 112 L2=0,ND(2),STEP
  DL=(L1/10.D0)/(1.D0+L2/10.D0)
   DO 101 J=1,NR(1)
   IF (CCC.EQ.1.OR.CCC.EQ.2) THEN
```

```
ZA = (R(1,J)-L1/10,D0)/(1,D0+SGN*L2/10,D0)
     ZB = (R(1,J+1)-L1/10,D0)/(1,D0+SGN*L2/10,D0)
    P(1,J) = DNML(ZB)-DNML(ZA)
    ENDIF
    IF (CCC.EQ.3) THEN
    ZA=R(1,J)
     ZB=R(1,J+1)
     P(1,J)=PRNCST(ZB,IDF,DL,IFAULT)
         -PRNCST(ZA,IDF,DL,IFAULT)
  &
    ENDIF
    CONTINUE
101
    DO 102 J=1,NR(2)
    IF (CCC.EQ.1) THEN
    ZA=(D2(M)+R(2,J)*D3(M))/(1.D0+SGN*L2/10.D0)
    IF (ZA.LT.0.D0) ZA=0.D0
    ZB=(D2(M)+R(2,J+1)*D3(M))/(1.D0+SGN*L2/10.D0)
     IF (ZB.LT.0.D0) ZB=0.D0
     P(2,J) = RNGPI(ZB,M,IFAULT)
  &
          -RNGPI(ZA,M,IFAULT)
    ENDIF
    IF (CCC.EQ.2.OR.CCC.EQ.3) THEN
    ZA=(C4+R(2,J)*DSQRT(1.D0-C4*C4))/(1.D0+SGN*L2/10.D0)
    IF (ZA.LT.0.D0) ZA=0.D0
    ZA=IDF*ZA*ZA
    ZB=(C4+R(2,J+1)*DSQRT(1.D0-C4*C4))/(1.D0+SGN*L2/10.D0)
    IF (ZB.LT.0.D0) ZB=0.D0
    ZB=IDF*ZB*ZB
    P(2,J)=DCHISQ(ZB,IDF)-DCHISQ(ZA,IDF)
    ENDIF
 102 CONTINUE
   N = 1
    DO 105 CC=1,2
    DO 104 I=1.NS(CC)-1
    U(CC,I) = 0.D0
    DO 103 J=1,NR(CC)
     IF (Q(CC,I,J).NE.NS(CC))
        U(CC,I)=U(CC,I)+P(CC,J)
  &
 103 CONTINUE
    U(CC,I)=1.0D0-U(CC,I)
 104 CONTINUE
    PDF(CC,1) = U(CC,1)
    CUM(CC) = PDF(CC,1)
    CDF(CC,1) = CUM(CC)
    CK(CC) = 0
 105 CONTINUE
C*
 106 N=N+1
   DO 110 CC=1,2
    DO 108 I=1,NS(CC)-1
     L(CC,I) = 0.D0
    DO 107 J=1,NR(CC)
      IF (Q(CC,I,J).NE.NS(CC))
```

```
&
        L(CC,I)=L(CC,I)+P(CC,J)*U(CC,Q(CC,I,J))
      CONTINUE
 107
 108 CONTINUE
    IF (U(CC,1).NE.0.D0.AND.CUM(CC).NE.1.D0) THEN
    LH = L(CC,1)/U(CC,1)
    LP(CC) = (1.D0-CUM(CC)-L(CC,1))/(1.D0-CUM(CC))
     TP = DABS(LH-LP(CC))
     IF (N.GT.MINN.AND.TP.LT.0.000001D0) CK(CC)=1
    ENDIF
    IF (N.GT.MAXN) CK(CC)=1
    DO 109 I=1,NS(CC)-1
     U(CC,I) = L(CC,I)
 109 CONTINUE
    PDF(CC,N) = L(CC,1)
    CUM(CC) = CUM(CC) + L(CC,1)
    CDF(CC,N) = CUM(CC)
 110 CONTINUE
    IF (CK(1).EQ.0.OR.CK(2).EQ.0) GOTO 106
C^*
    ARL=1.D0
    ARL1=1.D0
    ARL2=1.D0
    P1LT2=0.D0
    P1EO2=0.D0
    DO 111 I=1,N
     ARL=ARL+(1.D0-CDF(1,I))*(1.D0-CDF(2,I))
     ARL1=ARL1+(1.D0-CDF(1,I))
     ARL2=ARL2+(1.D0-CDF(2,I))
     P1LT2=P1LT2+PDF(1,I)*(1.D0-CDF(2,I))
     P1EQ2=P1EQ2+PDF(1,I)*PDF(2,I)
111
    CONTINUE
    TP=(1.D0-LP(1))*(1.D0-LP(2))*(1.D0-LP(1)*LP(2))
    TP=LP(1)*LP(1)*LP(2)*LP(2)*PDF(1,N)*PDF(2,N)/TP
   ARL=ARL+TP
   TP=LP(1)/(1.D0-LP(1))
    TP=TP*TP
    ARL1 = ARL1 + TP*PDF(1,N)
    TP=LP(2)/(1.D0-LP(2))
    TP=TP*TP
    ARL2=ARL2+TP*PDF(2,N)
    TP=(1.D0-LP(2))*(1.D0-LP(1)*LP(2))
    TP=LP(1)*LP(2)*LP(2)*PDF(1,N)*PDF(2,N)/TP
    P1LT2=P1LT2+TP
    TP=LP(1)*LP(2)*PDF(1,N)*PDF(2,N)/(1.D0-LP(1)*LP(2))
    P1EQ2=P1EQ2+TP
    P1LE2=P1LT2+P1EQ2
   TP=(ARL1*ARL2)/(ARL1+ARL2-1)
    WRITE(*,60) L1/10.D0,1.D0+SGN*L2/10.D0,
  &
           ARL1, ARL2, ARL, TP, P1LE2
    WRITE(60,60) L1/10.D0,1.D0+SGN*L2/10.D0,
           ARL1, ARL2, ARL, TP, P1LE2
  &
     FORMAT(2(F4.2,1X),4(F8.2,1X),F7.5)
60
```

112 CONTINUE	
113 CONTINUE	
CLOSE(60)	
C*	
END C*	
C*	
C*	
C*	
C*************************************	******
C* ALGORITHM AS 126 APPLIED STATISTICS (1978)	*
C* VOL 27 NO 2	*
C*	*
C* COMPLITES THE PROBABILITY OF THE NORMAL RANGE	*
C* CIVEN T THE HODED I MIT OF INTECDATION AND N	*
C' UIVEN I, THE UPPER LIMIT OF INTEGRATION, AND N,	•
C*************************************	****
C*	
DOUBLE PRECISION FUNCTION RNGPI(T,N,IFAULT)	
INTEGER N,I,IFAULT	
DOUBLE PRECISION A,B,C,DNML,G(8),H(8),RISF,	
& T.X.XL.Y	
C*	
DATA G(1) G(2) G(3) G(4) G(5) G(6) G(7) G(8)	
$\frac{1}{2}$ /0 /0//675D0 0 /722875115D0 0 /228156012D0	
$k_{0}^{-0.4747004075D0}, 0.4722075115D0, 0.4520150012D0, 0.4520150012D0, 0.47220750012D0, 0.2777020002000000000000000000000000000$	
& 0.5777022042D0, 0.5009501222D0, 0.2290005000D0, 0.1409017754D0, 0.04750625402D0/	
& 0.1408017754D0, 0.04750625492D0/	
DATA $H(1), H(2), H(3), H(4), H(5), H(6), H(7), H(8)$	
& /0.01357622971D0, 0.03112676197D0, 0.04757925584D0,	
& 0.06231448563D0, 0.07479799441D0, 0.08457825969D0,	
& 0.09130170752D0, 0.09472530523D0/	
C*	
RISF(X)=0.3989422804D0*EXP(-0.5D0*X*X)*	
& $(DNML(X)-DNML(X-T))**(N-1)$	
C*	
IFALII T-1	
PNCPI-0 D0	
I = (T I = 0 D O O D N I = 1) DETIIDN	
$II^{(1,LL,0,D,0,0,K,N,LL,1)} KL^{(1,LL,0,N,1,LL,1)} KL^{(1,LL,0,D,0,0,K,N,LL,1)} KL^{(1,LL,0,D,0,0,K,N,LL,1)}$	
XL=0.5D0*1	
A=0.5D0*(8.D0+XL)	
B=8.D0-XL	
Y=0.D0	
DO 1 I=1,8	
C=B*G(I)	
Y=Y+H(I)*(RISF(A+C)+RISF(A-C))	
1 CONTINUE	
RNGPI=(2,D0*(DNML(XL)-0.5D0))**N+2 D0*B*Y*N	
IF (RNGPI GT 1 D0) RNGPI=1 D0	
RETURN	

END

```
C*
  DOUBLE PRECISION FUNCTION DNML(X)
C*
C COMPUTES THE CUMULATIVE DISTRIBUTION FUNCTION
C P(Y<=X) OF A RANDOM VARIABLE Y HAVING A
C STANDARD NORMAL DISTRIBUTION.
C*
  DOUBLE PRECISION X, Y, S, RN, ZERO, ONE, ERF, SQRT2, PI
  DATA SQRT2, ONE/1.414213562373095D0, 1.D0/
  DATA PI.ZERO/3.141592653589793D0.0.D0/
  Y=X/SORT2
  IF (X.LT.ZERO) Y=-Y
  S=ZERO
  DO 1 N=1,37
  RN=N
  S=S+DEXP(-RN*RN/25.D0)/N*DSIN(2.D0*N*Y/5.D0)
  CONTINUE
1
  S=S+Y/5.D0
  ERF=2.D0*S/PI
  DNML=(ONE+ERF)/2.D0
  IF (X.LT.ZERO) DNML=(ONE-ERF)/2.D0
  IF (X.LT.-8.3D0) DNML=ZERO
  IF (X.GT.8.3D0) DNML=ONE
  RETURN
  END
C*
C*
C*
                                                  *
C* ALGORITHM AS 5 APPL STATIST, 1968 VOL 17, P.193
                                                  *
C*
                                                  *
C* COMPUTES LOWER TAIL AREA OF NON-CENTRAL
                                                  *
C* T-DISTRIBUTION
C*
C*
  REAL*8 FUNCTION PRNCST(ST, IDF, D, IFAULT)
C*
C ALGORITHM AS 5 APPL. STATIST. (1968) VOL. 17, P.193
                                                  *
C^*
                                                  *
C COMPUTES LOWER TAIL AREA OF NON-CENTRAL T-DISTRIBUTION*
C*
  REAL*8 ST,D,G1,G2,G3,ZERO,ONE,TWO,HALF,EPS,EMIN,F,
  & A,B,RB,DA,DRB,FMKM1,FMKM2,SUM,AK,FK,FKM1,
  & ALNORM, TFN, ALOGAM, ZSQRT, ZEXP
C*
C CONSTANTS - G1 IS 1.0/SQRT(2.0*PI)
С
      G2 IS 1.0/(2.0*PI)
С
      G3 IS SQRT(2.0*PI)
```

C*

```
DATA G1,G2,G3/0.3989422804,0.1591549431,2.5066282746/
  DATA ZERO, ONE, TWO, HALF, EPS, EMIN
  & /0.0,1.0,2.0,0.5,1.0E-6,12.5/
C^*
  ZSQRT(A)=DSQRT(A)
  ZEXP(A)=DEXP(A)
C*
  F=IDF
  IF (IDF.GT.100) GOTO 50
  IFAULT=0
  IOE=MOD(IDF,2)
  A=ST/ZSQRT(F)
  B = F/(F + ST^{**2})
  RB=ZSQRT(B)
  DA=D*A
  DRB=D*RB
  SUM=ZERO
  IF (IDF.EQ.1) GOTO 30
  FMKM2=ZERO
  IF (ABS(DRB).LT.EMIN) FMKM2=A*RB*ZEXP(-HALF*DRB**2)
  & *ALNORM(A*DRB.,FALSE.)*G1
  FMKM1=B*DA*FMKM2
  IF (ABS(D).LT.EMIN)
  & FMKM1=FMKM1+B*A*G2*ZEXP(-HALF*D**2)
  IF (IOE.EQ.0) SUM=FMKM2
  IF (IOE.EQ.1) SUM=FMKM1
  IF (IDF.LT.4) GOTO 20
  IFM2=IDF-2
  AK=ONE
  FK=TWO
  DO 10 K=2,IFM2,2
  FKM1=FK-ONE
  FMKM2=B*(DA*AK*FMKM1+FMKM2)*FKM1/FK
  AK=ONE/(AK*FKM1)
  FMKM1=B*(DA*AK*FMKM2+FMKM1)*FK/(FK+ONE)
  IF (IOE.EQ.0) SUM=SUM+FMKM2
  IF (IOE.EQ.1) SUM=SUM+FMKM1
  AK=ONE/(AK*FK)
  FK=FK+TWO
10 CONTINUE
20 IF (IOE.EQ.0) GOTO 40
30 PRNCST=ALNORM(DRB,.TRUE.)+TWO*(SUM+TFN(DRB,A))
  RETURN
40 PRNCST=ALNORM(D,.TRUE.)+SUM*G3
  RETURN
C*
C NORMAL APPROXIAMTION - K IS NOT TESTED AFTER THE TWO CALLS
C OF ALOGAM, BECAUSE A FAULT IS IMPOSSIBLE WHEN F EXCEEDS 100
C*
```

50 IFAULT=1 A=ZSQRT(HALF*F)*ZEXP(ALOGAM(HALF*(F-ONE),K)

& -ALOGAM(HALF*F,K))*D PRNCST=ALNORM((ST-A)/ZSQRT(F*(ONE+D**2)) & /(F-TWO)-A**2),.FALSE.) RETURN END C* REAL*8 FUNCTION ALNORM(X, UPPER) C* C* ALGORITHM AS 66 APPL. STATIST. (1973) VOL.22, P.424 * C^* * C* EVALUATES THE TAIL AREA OF THE STANDARDIZED NORMAL * * C* CURVE FROM X TO INFINITY IF UPPER IS .TRUE. OR FROM * C* MINUS INFINITY TO X IF UPPER IS .FALSE. C* * REAL*8 LTONE, UTZERO, ZERO, HALF, ONE, CON, A1, A2, A3, & A4,A5,A6,A7,B1,B2,B3,B4,B5,B6,B7,B8,B9, & B10,B11,B12,X,Y,Z,ZEXP LOGICAL UPPER, UP C* C* LTONE AND UTZERO MUST BE SET TO SUIT THE PARTICULAR C* COMPUTER (SEE INTRODUCTORY TEXT) **C*** DATA LTONE, UTZERO /7.0, 18.66/ DATA ZERO, HALF, ONE, CON /0.0, 0.5, 1.0, 1.28/ DATA A1,A2,A3,A4,A5,A6,A7 & /0.398942280444, 0.399903438504, 5.75885480458, & 29.8213557808, 2.62433121679, 48.6959930692, & 5.92885724438/ DATA B1,B2,B3,B4,B5,B6,B7,B8,B9,B10,B11,B12 & /0.398942280385, 3.8052E-8, 1.00000615302, & 3.98064794E-4, 1.98615381364, 0.151679116635, & 5.29330324926, 4.8385912808, 15.1508972451, & 0.742380924027, 30.789933034, 3.99019417011/ **C*** ZEXP(Z)=DEXP(Z)C* **UP=UPPER** Z=X IF (Z.GE.ZERO) GOTO 10 UP=.NOT.UP Z = -Z10 IF (Z.LE.LTONE.OR.UP.AND.Z.LE.UTZERO) GOTO 20 ALNORM=ZERO GOTO 40 20 Y=HALF*Z*Z IF (Z.GT.CON) GOTO 30 C* ALNORM=HALF-Z*(A1-A2*Y/(Y+A3-A4/(Y+A5+A6/(Y+A7))))

```
GOTO 40
```

C* 30 ALNORM=B1*ZEXP(-Y)/(Z-B2+B3/(Z+B4+B5/ (Z-B6+B7/(Z+B8-B9/(Z+B10+B11/(Z+B12)))))) & C* 40 IF (.NOT.UP) ALNORM=ONE-ALNORM RETURN END C^* REAL*8 FUNCTION TFN(X,FX) C* C* ALGORITHM AS 76 APPL. STATIST. (1974) VOL. 23, P. 455 * * C* * C* CALCULATES THE T-FUNCTION OF OWEN, USING GAUSSIAN * C* OUADRATURE C^* REAL*8 U(5),R(5),X,FX,TP,TV1,TV2,TV3,TV4,ZERO, & QUART, HALF, ONE, TWO, R1, R2, RT, XS, X1, X2, FXS, & ZABS, ZEXP, ZLOG, ZSIGN, ZATAN C^* DATA U(1),U(2),U(3),U(4),U(5) /0.0744372, 0.2166977, 0.3397048, & & 0.4325317, 0.4869533/ C* DATA R(1),R(2),R(3),R(4),R(5) /0.1477621, 0.1346334, 0.1095432, & & 0.0747257, 0.0333357/ C^* DATA NG, TP, TV1, TV2, TV3, TV4 /5, 0.159155, 1.0E-35, & 15.0, 15.0, 1.0E-5/ & **C*** DATA ZERO, QUART, HALF, ONE, TWO & /0.0, 0.25, 0.5, 1.0, 2.0/ C* ZABS(X)=DABS(X) ZEXP(X)=DEXP(X)ZLOG(X)=DLOG(X)ZSIGN(X1,X2)=DSIGN(X1,X2)ZATAN(X)=DATAN(X)**C*** C TEST FOR X NEAR ZERO C^* IF (ZABS(X).GE.TV1) GOTO 5 TFN=TP*ZATAN(FX) RETURN C^* C TEST FOR LARGE VALUES OF ABS(X) C* 5 IF (ZABS(X).GT.TV2) GOTO 10 C*

C TEST FOR FX NEAR ZERO C* IF (ZABS(FX).GE.TV1) GOTO 15 10 TFN=ZERO RETURN C* C TEST WHETHER DABS(FX) IS SO LARGE THAT IT MUST BE C TRUNCATED C^* 15 XS=-HALF*X*X X2=ZABS(FX)FXS=FX*FX IF (ZLOG(ONE+FXS)-XS*FXS.LT.TV3) GOTO 25 **C*** C COMPUTATION OF TRUNCATION POINT BY NEWTON ITERATION C^* X1=HALF*X2 FXS=QUART*FXS 20 RT=FXS+ONE X2=X1+(XS*FXS+TV3-ZLOG(RT))/(TWO*X1* & (ONE/RT-XS)) FXS=X2*X2 IF (ZABS(X2-X1).LT.TV4) GOTO 25 X1=X2GOTO 20 **C*** C GAUSSIAN QUADRATURE C* 25 RT=ZERO DO 30 I=1.NG R1=ONE+FXS*(HALF+U(I))**2 R2=ONE+FXS*(HALF-U(I))**2 RT=RT+R(I)*(ZEXP(XS*R1)/R1+ZEXP(XS*R2)/R2)30 CONTINUE TFN=ZSIGN(RT*X2*TP,FX) RETURN **END C*** REAL*8 FUNCTION ALOGAM(X.IFAULT) C* ALGORITHM ACM 291, COMM. ACM. (1966) VOL.9, P.684 * C^* * * C* EVALUATES NATURAL LOGARITHM OF GAMMA(X) * C* FOR X GREATER THAN ZERO REAL*8 A1, A2, A3, A4, A5, F, X, Y, Z, ZLOG, & HALF,ZERO,ONE,SEVEN **C*** C* THE FOLLOWING CONSTANTS ARE ALOG(2PI)/2, C* 1/160. 1/1260. 1/360 AND 1/12 **C*** DATA A1,A2,A3,A4,A5

& /0.918938533204673, 0.000595238095238, & 0.000793650793651, 0.00277777777778, & 0.0833333333333333/ C* DATA HALF, ZERO, ONE, SEVEN & /0.5, 0.0, 1.0, 7.0/ C^* ZLOG(F)=DLOG(F)C* ALOGAM=ZERO IFAULT=1 IF (X.LE.ZERO) RETURN IFAULT=0 Y=X F=ZERO IF (Y.GE.SEVEN) GOTO 30 F=Y 10 Y=Y+ONE IF (Y.GE.SEVEN) GOTO 20 F=F*Y GOTO 10 20 F=-ZLOG(F)30 Z=ONE/(Y*Y) ALOGAM=F+(Y-HALF)*ZLOG(Y)-Y+A1 & +(((-A2*Z+A3)*Z-A4)*Z+A5)/Y RETURN END **C*** **C* THIS DOUBLE PRECISION FUNCTION ROUTINE COMPUTES** * C^* * C^* SQRT(2)*GAMMA((M*(N-1)+1)/2) * C^* * C4 = ----- C^* SQRT(M*(N-1))*GAMMA(M*(N-1)/2) * C^* C^* DOUBLE PRECISION FUNCTION CIV(M,N) C* INTEGER I,J,K,M,N DOUBLE PRECISION G1,G2,XK **C*** $K = M^{*}(N-1)$ IF (M.EQ.0) K = N-1XK = K C^* G1 = 0.564189583D0G2 = 0.886226925D0IF (K.EQ.1) CIV = G1IF (K.GE.2) CIV = G2IF (K.GT.2) THEN IF ((K/2)*2.NE.K) THEN

```
J = (K+1)/2
   CIV = G1
   DO 100 I=2,J
    CIV = ((2.D0*I-2.D0)/(2.D0*I-3.D0))*CIV
100
    CONTINUE
   ELSE
   J = K/2
   CIV = G2
   DO 200 I=2.J
    CIV = ((2.D0*I-1.D0)/(2.D0*I-2.D0))*CIV
200
    CONTINUE
   ENDIF
  ENDIF
C^*
  CIV = DSQRT(2.D0)*CIV*DSQRT(XK)/XK
C*
  RETURN
  END
C^*
C* COMPUTES THE CUMULATIVE DISTRIBUTION FUNCTION
                                                  *
C* P[Y<=X] OF A RANDOM VARIABLE Y HAVING A CHI
                                                  *
C* SQUARED DISTRIBUTION WITH N DEGREES OF FREEDOM
                                                  *
C* USING THE FUNCTION DNML.
C*
  DOUBLE PRECISION FUNCTION DCHISQ(X,N)
  INTEGER N
  DOUBLE PRECISION A, Y, S, E, C, Z, X1, X, DNML
  DOUBLE PRECISION PI, ONE, ZERO, HALF, LARGEX
  LOGICAL BIGX
C*
C* LARGEX IS THE LARGEST VALUE OF X SUCH THAT
                                                  *
                                                  *
C* DEXP(-X/2) IS ACCURATE FOR YOUR PARTICULAR
C* MACHINE.
                                                  *
C*
  DATA LARGEX.PI/174.99646D0.3.141592653589793D0/
  DATA ONE, ZERO, HALF/1.D0, 0.D0, 0.5D0/
  IF (X.LT.0.D0) WRITE(*,100) 'X',0
  IF (N.LT.1) WRITE(*,100) 'N',1
  IF (X.GE.0.D0.AND.N.GE.1) GOTO 10
  DCHISO=-ONE
  RETURN
10 A=HALF*X
  I=MOD(N+1,2)
  BIGX=.FALSE.
  IF(X.GT.LARGEX) BIGX=.TRUE.
  Y = DEXP(-A)
  IF (N.EQ.1.OR.BIGX) Y=ZERO
  S=Y
```

```
IF (I.EQ.0) S=2*DNML(-DSQRT(X))
IF (N.EQ.1) GOTO 30
X1=HALF*(N-1)
Z=(ONE+I)/2
IF (.NOT.BIGX) GOTO 40
E=ZERO
IF (I.EQ.0) E=DLOG(DSQRT(PI))
C=DLOG(A)
20 IF (Z.GT.X1) GOTO 30
```

- E=E+DLOG(Z) S=S+DEXP(C*Z-A-E) Z=Z+ONE GOTO 20
- 30 DCHISQ=ONE-S RETURN
- 40 E=ONE IF (I.EQ.0) E=ONE/DSQRT(PI*A) C=ZERO
- 50 IF (Z.GT.X1) GOTO 60 E=E*A/Z C=C+E Z=Z+ONE GOTO 50 60 DCHISQ=ONE-C*Y-S
- b) DCHISQ=ONE-C*1-S RETURN
 100 FORMAT(' IN THE FUNCTION DCHISQ(X,N) THE ', &'PARAMETER ',A1,' MUST BE >= ',I1) END

PGM2.OUT

The program outputs (the number of shifts in the mean), (the number of shifts in the standard deviation), the average run lengths (ARLs) for the individual chart as well as the combined chart and $P[N = N_1]$, the probability the \overline{X} -chart is more likely to signal on or before the R-chart into an external data file called PGM2.OUT.

Appendix II PROGRAMS FOR COMBINED MARKOV CHAIN APPROACH

Diagram of Programs for the Combined Markov Chain Approach



RULES

Description

Rules is an external data file that defines the charts. For the combined Markov chain approach a user would save two sets of runs rules defining the two charts.

Program Description: PGM1B.FOR

This program finds the states of a Markov chain representation of a Shewhart control chart with supplementary runs rules of the form T(k,m,a,b). The rules defining the chart are read in from an external file called "RULES". Routines find the regions of the chart, the length of the state vector and the pointers to the end of the sub vector associated with each

runs rule. The value of the present indicator variable is determined by runs rule and region combinations. The program then finds the state to state transitions by regions and sorts the states in ascending order of their base two representations. Any duplicate states are removed. Then the next-state transitions are numbered. Finally, the program outputs the state, next-state transition matrix.

Program Listing

```
C* PROGRAM 1 (PGM 1B)
                                          *
                                          *
C* THIS PROGRAM FINDS THE STATES OF A MARKOV CHAIN
C* REPRESENTATION OF A SHEWHART CONTROL CHART WITH
                                          *
                                          *
C* SUPPLEMENTARY RUNS RULES OF THE FORM T(K.M.A.B).
C*
 CHARACTER*80 FMT
 INTEGER CC, DIM, DIMC
 PARAMETER(DIM=100,DIMC=200)
 INTEGER H,I,J,L,NS(2),NSC,NR(2),NRC,MR,CK,CX,
 & QH,SG,NT,NV,TMP,QQNS,K(20),M(20),D(20),
 & PS(58),NX(58),X(20,10),Q(2,DIM,10),QQ(DIM),
 & QC(DIMC,50),S(20)
 REAL A(20),B(20),R(2,41),TP
C*
C* THIS ROUTINE INPUTS THE RULES DEFINING THE CHART.
                                          *
C*
  OPEN (50, FILE='RULES', STATUS='OLD')
 DO 899 CC=1,2
 READ(50,50) FMT
50 FORMAT(A80)
 READ(50,FMT) NT
 DO 101 I=1,NT
  READ(50,FMT) K(I),M(I),A(I),B(I)
101 CONTINUE
C*
C* THIS ROUTINE FINDS THE REGIONS OF THE CHART.
C*
 R(CC,1) = -9
 DO 201 I=1,NT
  R(CC,2*I) = A(I)
  R(CC, 2*I+1) = B(I)
201 CONTINUE
```

```
R(CC, 2*NT+2) = +9
  MR = 2*NT+1
  NR(CC) = MR
202 \text{ CK} = 0
  DO 204 J=1,MR
   IF (R(CC,J).EQ.R(CC,J+1).AND.J.LE.NR(CC)) THEN
   DO 203 L=J,NR(CC)
    R(CC,L) = R(CC,L+1)
    CONTINUE
203
   NR(CC) = NR(CC)-1
   CK = 1
   ENDIF
   IF (R(CC,J).GT.R(CC,J+1)) THEN
   TP = R(CC,J)
    R(CC,J) = R(CC,J+1)
    R(CC,J+1) = TP
   CK = 1
   ENDIF
204 CONTINUE
  MR = MR-1
  IF (MR.GT.NR(CC)) MR=NR(CC)
  IF (CK.EQ.1.AND.MR.GE.1) GOTO 202
C*
*
C* THIS ROUTINE FINDS THE LENGTH OF THE STATE VECTOR
C* AND THE POINTERS TO THE END OF THE SUBVECTOR
                                                   *
C* ASSOCIATED WITH EACH RUNS RULE.
                                                   *
C*
  CK = 0
  NV = 0
  DO 301 I=1,NT
   NV = NV + M(I) - 1
   IF (K(I).LT.M(I)) CK = 1
301 CONTINUE
  IF (CK.EQ.0) NV = NV+1
  D(1) = M(1)-1
  DO 302 I=2,NT
   D(I) = D(I-1)+M(I)-1
   IF(M(I).EQ.1)D(I) = 0
302 CONTINUE
C^*
C* THIS ROUTINE DETERMINES THE VALUE OF THE PRESENT
                                                   *
                                                   *
C* INDICATOR VARIABLE BY RUNS RULE AND REGION
                                                   *
C* COMBINATION.
C*
  DO 402 I=1,NT
   DO 401 J=1,NR(CC)
    X(I,J) = 0
    IF (A(I).LE.R(CC,J).AND.R(CC,J+1).LE.B(I))
```

```
&
      X(I,J) = 1
 401 CONTINUE
402 CONTINUE
C*
C* THIS ROUTINE DETERMINES THE STATE TO STATE
                                                         *
C* TRANSITIONS BY REGIONS.
                                                          *
C^*
  QQ(1) = 0
  QQNS = 2**NV-1
  NS(CC) = 1
  H = 1
 500 \text{ QH} = \text{QQ(H)}
  DO 501 L=1,NV
   PS(L) = OH-2*(OH/2)
   OH = OH/2
 501 CONTINUE
  DO 503 I=1,NT
   S(I) = 0
   IF (M(I).GT.1) THEN
    DO 502 L=D(I)-M(I)+2,D(I)
     S(I) = S(I) + PS(L)
 502
     CONTINUE
   ENDIF
 503 CONTINUE
  DO 509 J=1,NR(CC)
   SG = 0
   DO 506 I=1,NT
    IF (SG.EQ.0) THEN
     IF (S(I)+X(I,J).GE.K(I)) THEN
      SG = 1
     ELSE
      IF (M(I).GT.1) NX(D(I)-M(I)+2)=X(I,J)
      IF (M(I).GT.2) THEN
       DO 504 L=D(I)-M(I)+3,D(I)
        NX(L) = PS(L-1)
504
        CONTINUE
      ENDIF
     ENDIF
     IF (X(I,J).EQ.0.AND.M(I).GT.1) THEN
      TMP = S(I)-PS(D(I))+1
      L = D(I)
      CK = 0
505
       IF (NX(L).EQ.1) THEN
       CK = 1
       IF (TMP.LT.K(I)) THEN
        NX(L) = 0
        TMP = TMP-1
        CK = 0
       ENDIF
      ENDIF
```

```
L = L - 1
      TMP = TMP+1
      IF (CK.EQ.0.AND.L.GE.D(I)-M(I)+2)
  &
       GOTO 505
     ENDIF
    ENDIF
506 CONTINUE
   IF (SG.EQ.0) THEN
    QH = NX(1)
    DO 507 L=2,NV
     QH = QH + NX(L)*(2**(L-1))
507
    CONTINUE
    CK = 0
    DO 508 L=1,NS(CC)
     IF (CK.EQ.0.AND.QH.EQ.QQ(L)) THEN
      Q(CC,H,J) = QQ(L)
      CK = 1
     ENDIF
508
    CONTINUE
    IF (CK.EQ.0) THEN
     NS(CC) = NS(CC)+1
     QQ(NS(CC)) = QH
     Q(CC,H,J) = QH
    ENDIF
   ELSE
    Q(CC,H,J) = QQNS
   ENDIF
509 CONTINUE
  H = H + 1
  IF (H.LE.NS(CC)) GOTO 500
  NS(CC) = NS(CC)+1
  QQ(NS(CC)) = QQNS
  DO 510 J=1,NR(CC)
   Q(CC,NS(CC),J) = QQNS
510 CONTINUE
C*
*
C* THIS ROUTINE SORTS THE STATES IN ASCENDING ORDER
                                                        *
C* OF THEIR BASE TWO REPRESENTATIONS.
C*
600 \text{ H} = 0
  CK = 0
  DO 602 I=2,NS(CC)-H
   IF (QQ(I-1).GT.QQ(I)) THEN
    CK = 1
    TMP = QQ(I-1)
    QQ(I-1) = QQ(I)
    OO(I) = TMP
    DO 601 J=1,NR(CC)
     TMP = Q(CC, I-1, J)
     Q(CC,I-1,J) = Q(CC,I,J)
```

```
Q(CC,I,J) = TMP
601
     CONTINUE
   ENDIF
602 CONTINUE
  H = H+1
  IF (CK.EQ.1) GOTO 600
C*
C^*
C* THIS ROUTINE REMOVES ANY DUPLICATE STATES.
                                                   *
C^*
700 \text{ CK} = 0
  I = 1
701 \text{ H} = \text{I} + 1
702 \text{ CX} = 0
  DO 703 J=1,NR(CC)
   IF (Q(CC,I,J).NE.Q(CC,H,J)) CX=1
703 CONTINUE
  IF (CX.EQ.0) THEN
   TMP = QQ(H)
   DO 705 L=1.H-1
    DO 704 J=1,NR(CC)
    IF (Q(CC,L,J).EQ.TMP) Q(CC,L,J)=QQ(I)
704
    CONTINUE
705 CONTINUE
   DO 707 L=H,NS(CC)-1
   QQ(L) = QQ(L+1)
    DO 706 J=1,NR(CC)
     Q(CC,L,J) = Q(CC,L+1,J)
    IF (Q(CC,L,J).EQ.TMP) Q(CC,L,J)=QQ(I)
706 CONTINUE
707 CONTINUE
   NS(CC) = NS(CC)-1
   CK = 1
  ENDIF
  H = H + 1
  IF (H.LT.NS(CC)) GOTO 702
  I = I + 1
  IF (I.LT.NS(CC)-1) GOTO 701
  IF (CK.EQ.1) GOTO 700
C*
C* THIS ROUTINE NUMBERS THE NEXT-STATE TRANSITIONS.
C^*
  DO 803 I=1,NS(CC)
   DO 802 J=1,NR(CC)
    IF (Q(CC,I,J).LT.QQNS) THEN
    CK = 0
    L = 1
801
      IF (Q(CC,I,J).EQ.QQ(L)) THEN
```

```
Q(CC,I,J) = L
     CK = 1
    ENDIF
    L = L + 1
    IF (CK.EQ.0.AND.L.LT.NS(CC)) GOTO 801
   ELSE
    Q(CC,I,J) = NS(CC)
   ENDIF
802 CONTINUE
803 CONTINUE
899 CONTINUE
  CLOSE (50)
C*
C* THIS ROUTINE CREATES THE STATE, NEXT-STATE
                                                   *
                                                   *
C* TRANSITION MATRIX FOR THE COMBINED CHART
C*
  NSC = (NS(1)-1)*(NS(2)-1)+1
  NRC=NR(1)*NR(2)
  DO 904 I1=1,NS(1)-1
  DO 903 I2=1.NS(2)-1
   I = (I1-1)*(NS(2)-1)+I2
   DO 902 J1=1,NR(1)
   DO 901 J2=1,NR(2)
   J = (J1-1) NR(2) + J2
    QC(I,J)=(Q(1,I1,J1)-1)*(NS(2)-1)+Q(2,I2,J2)
    IF (Q(1,I1,J1).GE.NS(1)) QC(I,J)=NSC
    IF (Q(2,I2,J2),GE,NS(2)) QC(I,J)=NSC
901
    CONTINUE
902
   CONTINUE
903 CONTINUE
904 CONTINUE
  DO 906 J1=1,NR(1)
  DO 905 J2=1,NR(2)
   J = (J1-1) NR(2) + J2
   QC(NSC,J)=NSC
905 CONTINUE
906 CONTINUE
C*
C* THIS ROUTINE OUTPUTS THE STATE, NEXT-STATE
                                                   *
                                                   *
C* TRANSITION MATRIX.
C^*
9900 OPEN (60,FILE='PGM1.OUT',STATUS='OLD')
  WRITE(60,9961) NSC,NRC,NR(1),NR(2)
9961 FORMAT(4(I4,1X))
  DO 9963 CC=1,2
  WRITE(60,9962) (R(CC,J),J=1,NR(CC)+1)
9962 FORMAT(10(F9.5))
9963 CONTINUE
```

```
DO 9965 I=1,NSC
WRITE(60,9964) I,(QC(I,J),J=1,NRC)
9964 FORMAT(50(1X,I4))
9965 CONTINUE
CLOSE (60)
C*
STOP
END
```

PGM1.OUT

For the charts given in "**RULES**", the program PGM1B.FOR writes the Markov chain representation for each chart into this external output file.

Program Description: PGM2B.FOR

This program calculates the average run length (ARL), the standard deviation (STD), and selected percentage points of the run length distribution. The Markov chain representation of the chart is read in from an external file called "PGM1.OUT". A routine calculates the average run lengths and standard deviations of the chart for various positive standardized shifts in the mean. Various percentage points are then calculated. The program makes use of Algorithm AS 126 Applied Statistics (1978) Vol. 27, No. 2 which computes the probability of the normal range given T, the upper limit of integration, and N, the sample size. Subroutines included are a double precision function dnml(x) which computes the cumulative distribution function $P[y \ x]$ of a random variable y having a standard normal distribution.

Program Listing

C*************************************	*****
C* PROGRAM 2 (PGM 2) (STANDARDIZED REGIONS)	*
C* THIS PROGRAM CALCULATES THE AVERAGE RUN LENGTH	*
C* (ARL), THE STANDARD DEVIATION (STD), AND SELECTED	*
C* PERCENTAGE POINTS OF THE RUN LENGTH DISTRIBUTION.	*
C*************************************	*****
C*	
INTEGER CC,CV(11,11,9),DX,DV,I,IFAULT,II,J,J1,	

88

& J2,K,N,NCP,NDX,NDV,NSC,M,NRC,NR(2),Q(100,50),

& QQ(100),SS,STEPX,STEPV

DOUBLE PRECISION ARL(11,11),CDF(50),CP(9),CUM,

& DNML,D2(25),D3(25),FCDF,L(100),LH,LP,LX,LV,

- & P(50), PCDF, PX(10), PV(10), R(2, 10), RNGPI,
- & STD(11,11),U(100),ZA,ZB

C*

	SS=1
	STEPX=1
	STEPV=1
	NCP=9
	CP(1)=0.01
	CP(2) = 0.05
	CP(3) = 0.10
	CP(4) = 0.25
	CP(5) = 0.50
	CP(6) = 0.75
	CP(7) = 0.90
	CP(8) = 0.95
	CP(9) = 0.99
C^*	- (-)

D2(2)=1.1283791671D0
D2(3) = 1.6925687506D0
D2(4) = 2.0587507460D0
$D_2(5) = 2.3259289473D0$
$D_{2}(6) = 2.5344127212D0$
$D_2(7) = 2.7043567512D0$
$D^{2}(8) = 2.8472006121D0$
$D^{2}(9) = 2.9700263244D0$
$D^{2}(10) = 3.0775054617D0$
$D^{2}(11) = 3.1728727038D0$
$D^{2}(12) = 3.2584552798D0$
$D^{2}(12) = 3.3259803541D0$
$D^{2}(14) = 3.4067631082D0$
$D^{2}(15) = 3.4718268899D0$
$D^{2}(16) = 3.5319827861D0$
$D^{2}(10) = 3.5517627601D0$ $D^{2}(17) = 3.5878839618D0$
$D^{2}(18) = 3.5676657616D0$
$D_2(10) = 3.0 + 0.003737700$
$D_2(19) = 3.0009050252D0$ $D_2(20) = 3.7340501106D0$
$D_2(20) = 3.7349301190D0$ $D_2(21) = 2.7783358208D0$
$D_2(21) = 3.7783338298D0$ $D_2(22) = 2.8103846424D0$
$D_2(22) = 3.8193840434D0$ $D_2(22) = 2.8582224222D0$
$D_2(23) = 3.6365234255D0$ $D_2(24) = 2.8052481485D0$
$D_2(24) = 3.6933461463D0$ $D_2(25) = 2.0206202105D0$
$D_2(23) = 3.9300292193D0$
D3(2)=0.7267604553D0

 C^*

D3(3)=0.7891977107D0 D3(4)=0.7740624738D0 D3(5)=0.7466376009D0 D3(6)=0.7191713092D0 D3(7)=0.6942311313D0

```
D3(8)=0.6721236717D0
  D3(9)=0.6525962151D0
  D3(10)=0.6352897762D0
  D3(11)=0.6198643117D0
  D3(12)=0.6060285277D0
  D3(13)=0.5935411244D0
  D3(14)=0.5822042445D0
  D3(15)=0.5718557265D0
  D3(16)=0.5623621426D0
  D3(17)=0.5536130572D0
  D3(18)=0.5455164487D0
  D3(19)=0.5379951043D0
  D3(20)=0.5309837904D0
  D3(21)=0.5244270274D0
  D3(22)=0.5182773314D0
  D3(23)=0.5124938181D0
  D3(24)=0.5070410861D0
  D3(25)=0.5018883188D0
C*
  DO 1 I=2,25
   D3(I) = DSQRT(D3(I))
  CONTINUE
1
C*
  WRITE(*,*) 'INPUT # OF SHIFTS IN THE MEAN.'
  READ(*,*) NDX
  WRITE(*,*) 'INPUT # OF SHIFTS IN THE STDEV.'
  READ(*,*) NDV
  WRITE(*,*) 'INPUT SAMPLE SIZE.'
  READ(*,*) M
C*
C* THIS ROUTINE INPUTS INFORMATION ABOUT THE CHART.
                                                      *
C*
  OPEN(50,FILE='PGM1.OUT',STATUS='OLD')
  READ(50,51) NSC,NRC,NR(1),NR(2)
51 FORMAT(4(I4,1X))
  DO 53 CC=1,2
   READ(50,52) (R(CC,J),J=1,NR(CC)+1)
52
    FORMAT(50(F9.5))
53
  CONTINUE
  DO 55 I=1,NSC
   READ(50,54) II,(Q(I,J),J=1,NRC)
54
    FORMAT(50(1X,I4))
55
   CONTINUE
  CLOSE (50)
C^*
C*
C*
C*
C* THIS ROUTINE CALCULATES THE AVERAGE RUN LENGTHS
                                                      *
```

C* AND STANDARD DEVIATIONS OF THE CHART FOR VARIOUS * * C* POSITIVE STANDARDIZED SHIFTS IN THE MEAN. C^* DO 116 DX=0,NDX,STEPX DO 115 DV=0,NDV,STEPV C^* DO 101 J1=1,NR(1) ZA=(R(1,J1)-DX/10.D0)/(1.D0+DV/10.D0) ZB=(R(1,J1+1)-DX/10.D0)/(1.D0+DV/10.D0) PX(J1)=DNML(ZB)-DNML(ZA) 101 CONTINUE C^* DO 102 J2=1,NR(2) ZA=(D2(M)+R(2,J2)*D3(M))/(1.D0+DV/10.D0) IF (ZA.LT.0.D0) ZA=0.D0 ZB = (D2(M)+R(2,J2+1)*D3(M))/(1.D0+DV/10.D0)IF (ZB.LT.0.D0) ZB=0.D0 PV(J2)=RNGPI(ZB,M,IFAULT) -RNGPI(ZA,M,IFAULT) & 102 CONTINUE C^* DO 104 J1=1,NR(1) DO 103 J2=1,NR(2) J = (J1-1) NR(2) + J2P(J)=PX(J1)*PV(J2)103 CONTINUE 104 CONTINUE C^* DO 106 I=1,NSC-1 U(I) = 0.D0DO 105 J=1,NRC IF (Q(I,J).NE.NSC) U(I)=U(I)+P(J) 105 CONTINUE U(I)=1.D0-U(I)106 CONTINUE CUM = U(1)ARL(DX+1,DV+1) = CUMSTD(DX+1,DV+1) = CUMCDF(0+1) = 0.D0CDF(1+1) = CUMCK = 0N = 1107 N = N+1DO 109 I=1,NSC-1 L(I) = 0.D0DO 108 J=1,NRC IF (Q(I,J).NE.NSC) L(I)=L(I)+P(J)*U(Q(I,J))108 CONTINUE 109 CONTINUE IF (U(1).NE.0.0.AND.CUM.NE.1.0) THEN LH = L(1)/U(1)

```
LP = (1-CUM-L(1))/(1-CUM)
    TP = DABS(LH-LP)
    IF (N.GT.9.AND.TP.LT.0.000001) CK=1
   ENDIF
   IF (N.GT.40) CK=1
   ARL(DX+1,DV+1) = ARL(DX+1,DV+1) + N*L(1)
   STD(DX+1,DV+1) = STD(DX+1,DV+1) + N*N*L(1)
   IF (CK.EQ.1) THEN
    TP = N/(1-LP) + 1/((1-LP)*(1-LP))
    ARL(DX+1,DV+1) = ARL(DX+1,DV+1)+LP*L(1)*TP
    TP = 1-LP
    TP = N*N/TP+(2*N-1)/(TP*TP)+2/(TP*TP*TP)
    STD(DX+1,DV+1) = STD(DX+1,DV+1)+LP*L(1)*TP
   ENDIF
   DO 110 I=1,NSC-1
    U(I) = L(I)
110 CONTINUE
   CUM = CUM + L(1)
   CDF(N+1) = CUM
   IF (CK.EQ.0) GOTO 107
   STD(DX+1,DV+1) = STD(DX+1,DV+1) - ARL(DX+1,DV+1) + ARL(DX+1,DV+1)
   STD(DX+1,DV+1) = DSQRT(STD(DX+1,DV+1))
C*
C* CALCULATION OF VARIOUS PERCENTAGE POINTS.
                                                          *
C^*
   I = 1
   DO 112 J=1.N
111
     CK = 0
    IF (CDF(J+1).GE.CP(I)) THEN
     CV(DX+1,DV+1,I) = J
     I = I + 1
     CK = 1
    ENDIF
    IF (CK.EQ.1.AND.I.LE.NCP) GOTO 111
112 CONTINUE
   FCDF = CDF(N+1)
   TP = CDF(N+1)-CDF(N)
   J = 1
113
   IF (I.GT.NCP) GOTO 115
   PCDF = CDF(N+1) + LH*TP*(1-LH**J)/(1-LH)
114 CK = 0
   IF (PCDF.GE.CP(I)) THEN
    CV(DX+1,DV+1,I) = N+J
    I = I + 1
    CK = 1
   ENDIF
   IF (CK.EQ.1.AND.I.LE.NCP) GOTO 114
   \mathbf{J} = \mathbf{J} + 1
   GOTO 113
115 CONTINUE
```

116 CONTINUE

```
C*
C* THIS ROUTINE PRINTS THE AVERAGE RUN LENGTHS (ARL),
                                                     *
C* STANDARD DEVIATIONS, AND PERCENTAGE POINTS BY
                                                     *
C* STANDARDIZED SHIFTS IN THE MEAN.
C*
200 WRITE(*,*) ARL(1,1)
  OPEN (60, FILE='PGM2.OUT', STATUS='OLD')
  WRITE(60,201) (CP(I),I=1,NCP)
201 FORMAT(40X,'PERCENTILES'/
       2X,'D',4X,'L',5X,'ARL',5X,'STD',
  &
  &
      4X,9(2X,F3.2))
  DO 204 DX=0.NDX.STEPX
  DO 203 DV=0,NDV,STEPV
   WRITE(60,202) DX/10.0,1.D0+SS*DV/10.D0,
  & ARL(DX+1,DV+1),STD(DX+1,DV+1),
  & (CV(DX+1,DV+1,I),I=1,NCP)
   FORMAT(2(F4.2,1X),F7.2,1X,F7.2,3X,9(1X,I4))
202
203 CONTINUE
204 CONTINUE
  CLOSE (60)
999 STOP
  END
C^*
*
C* ALGORITHM AS 126 APPLIED STATISTICS (1978)
                                                     *
C* VOL. 27, NO. 2
C^*
                                                     *
C* COMPUTES THE PROBABILITY OF THE NORMAL RANGE
                                                     *
C* GIVEN T, THE UPPER LIMIT OF INTEGRATION, AND N,
                                                     *
C* THE SAMPLE SIZE.
C*
  DOUBLE PRECISION FUNCTION RNGPI(T,N,IFAULT)
  INTEGER N.I.IFAULT
  DOUBLE PRECISION A, B, C, DNML, G(8), H(8), RISF,
  &
      T.X.XL.Y
C^*
  DATA G(1),G(2),G(3),G(4),G(5),G(6),G(7),G(8)
  & /0.4947004675, 0.4722875115, 0.4328156012,
  & 0.3777022042, 0.3089381222, 0.2290083888,
  & 0.1408017754, 0.04750625492/
C*
  DATA H(1),H(2),H(3),H(4),H(5),H(6),H(7),H(8)
  & /0.01357622971, 0.03112676197, 0.04757925584,
  & 0.06231448563, 0.07479799441, 0.08457825969,
  & 0.09130170752, 0.09472530523/
C*
  RISF(X)=0.3989422804*EXP(-0.5*X*X)*
       (DNML(X)-DNML(X-T))**(N-1)
  &
```

 C^*

```
IFAULT=1
  RNGPI=0.D0
  IF (T.LE.0.D0.OR.N.LE.1) RETURN
  IFAULT=0
  XL=0.5D0*T
  A=0.5D0*(8.D0+XL)
  B=8.D0-XL
  Y=0.D0
  DO 1 I=1,8
   C=B*G(I)
   Y=Y+H(I)*(RISF(A+C)+RISF(A-C))
  CONTINUE
1
  RNGPI=(2.D0*(DNML(XL)-0.5D0))**N+2.D0*B*Y*N
  IF (RNGPI.GT.1.D0) RNGPI=1.D0
  RETURN
  END
C*
C^*
C^*
  DOUBLE PRECISION FUNCTION DNML(X)
C*
C^*
C*
C* COMPUTES THE CUMULATIVE DISTRIBUTION FUNCTION
                                                      *
C* P(Y<=X) OF A RANDOM VARIABLE Y HAVING A
                                                      *
C* STANDARD NORMAL DISTRIBUTION.
                                                      *
C^*
  DOUBLE PRECISION X, Y, S, RN, ZERO, ONE, ERF, SQRT2, PI
  DATA SQRT2, ONE/1.414213562373095, 1.D0/
  DATA PI.ZERO/3.141592653589793.0.D0/
  Y=X/SORT2
  IF (X.LT.ZERO) Y=-Y
  S=ZERO
  DO 1 N=1,37
  RN=N
  S=S+DEXP(-RN*RN/25)/N*DSIN(2*N*Y/5)
  CONTINUE
1
  S=S+Y/5
  ERF=2*S/PI
  DNML=(ONE+ERF)/2
  IF (X.LT.ZERO) DNML=(ONE-ERF)/2
  IF (X.LT.-8.3D0) DNML=ZERO
  IF (X.GT.8.3D0) DNML=ONE
  RETURN
  END
```

PGM2.OUT

The program PGM2B.FOR prints the average run lengths (ARLs), standard deviations, and percentage points by standardized shifts in the mean into this external data file.